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Methods of Magnetotelluric Analysis

By

William E. Sims and F. X. Bostick, Jr. Department of Electrical Engineering

Technical Report No. 58 January 7, 1969

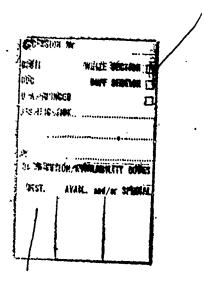
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ABSTRACT

Magnetotelluric prospecting is a method of geophysical exploration that makes use of the fluctuations in the natural electric and magnetic fields that surround the earth. These fields can be measured at the surface of the earth and they are related to each other by a surface impedance that is a function of the conductivity structure of the earth's substrata.

This report describes some new methods for analyzing and interpreting magnetotelluric data. A discussion is given of the forms of the surface impedance for various classes of models, including one, two and three dimensional models. Here, an n dimensional model is one in which the parameters describing the model are functions of at most n space coordinates. Methods are discussed for estimating the strike direction for data that is at least approximately two dimensional. A new linearized approach to the one dimensional problem is discussed. Subject to the approximations of the linearization, it is shown that under the appropriate transformations of the frequency and depth scales, the reciprocal of the surface impedance as a function of frequency is equal to the square root of the conductivity as a function of depth convolved with a linear response function that is somewhat like a low pass filter.

Included in this report is a comparison of several methods of estimating the auto and cross power density spectra of measured field data, and of several methods for estimating the surface impedance from these spectra. The effects of noise upon these estimates are considered in some detail. Special emphasis is given to several types of artificial noise including aliasing, round off or digitizer noise, and truncation effects. Truncation effects are of the most interest since they depend upon the particular window used in the spectral analysis.

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I. INTRODUCTION

Magnetotelluric prospecting is a relatively new method of geophysical exploration, although the electric and magnetic fields that it employs have long been observed. More than a century ago it was recognized by several investigators that a correlation existed between the variations in the telluric currents and the geomagnetic field. In 1940 Chapman and Bartels reviewed the various theories on the relationship between these fields. In the late 1940's and early 1950's several investigators such as Tikhonov in the USSR; Kato, Kikuchi, Rikitake, and Yokoto in Japan; and Cagniard in France began to recognize the electromagnetic nature of these fields.

In 1953 Cagniard published a paper in which he gave a quantitative description of the relationship between the electric and magnetic fields at the surface of a horizontally layered earth. Soon thereafter many people began making theoretical and experimental contributions to the field of magnetotellurics. By the late 1950's, it was recognized by several investigators that the scalar impedance described by Cagniard was not sufficient to describe many of the frequently encountered geologic situations. For an anisotropic or laterally inhomogeneous earth, the impedance becomes a tensor quantity (Neves, 1957), (Rankin, 1960), (Cantwell, 1960), (Kovtun, 1961), (Rokityanskii, 1961), (d'Erceville and Kunetz, 1962), (Bostick and Smith, 1962), (Srivastava, 1963). Principal contributors to the growing body of literature on magnetotellurics, in addition to those previously mentioned, include Berdichevskii, Vladimirov, and Kolmakov in the USSR, Porstendorfer in Germany, Adam and Vero of the Hungarian Academy of Sciences, Fournier in France, and many people in the U.S.A. and Canada. Hugo Fournier (1966) has a comprehensive history and bibliography of the science of magnetotellurics.

The tensor relationship between the E (electric) and H (magnetic) fields at any given frequency can be expressed as

$$\begin{bmatrix} E_{x} \\ E_{y} \end{bmatrix} = \begin{bmatrix} Z_{xx} & Z_{xy} \\ Z_{yx} & Z_{yy} \end{bmatrix} \begin{bmatrix} H_{x} \\ H_{y} \end{bmatrix}$$
(1.1)

where rectangular cartesian coordinates have been indicated. This tensor impedance Z, a function of frequency and space coordinates, depends upon the conductivity of the earth in the surrounding area, and if the horizontal wavelengths of the incident fields are sufficiently long, Z will be independent of time and source polarization. Therefore, Z can be a useful measure of the conductivity structure of the earth, and in fact it can sometimes be interpreted almost completely in terms of a simplified earth model.

The magnetotelluric problem can conveniently be divided into three parts: data acquisition, analysis, and modeling. Data acquisition includes the instrumentation and all of the field work involved with recording the electric and magnetic field variations. Analysis includes processing the field measurements to determine estimates of the Z tensor and other related parameters. Modeling consists of interpreting this impedance tensor in terms of a particular earth model.

The research that went into this thesis was aimed at developing better methods of magnetotelluric analysis and interpretation. The thesis itself provides for the first time a unified treatment of the techniques developed as a result of this research. The treatment is facilitated by first considering the forms of theoretical impedance tensors for several classes of models.

Next, various methods are presented for estimating actual impedance tensors from measured field data. Finally, the effects that various types of noise have upon the impedance estimates are considered.

II. ONE DIMENSIONAL MODELS

In this chapter several one dimensional models, that is, models which have medium parameters that are functions of only one space coordinate will be considered.

A. Homogeneous Half Space Model

The simplest of all possible models is one in which the earth is considered to be a homogeneous, isotropic half space of conductivity σ , permittivity ε , permeability μ . Within any medium of constant σ , ε , and μ , if we assume time variations of the form $e^{j\omega t}$, Maxwell's equations

$$\nabla \times \vec{E} = -j\omega u \vec{H}$$
 (2.1)

$$\nabla \times \vec{H} = (\sigma + j\omega \varepsilon) \vec{E}$$
 (2.2)

$$\nabla \cdot \vec{H} = 0 \tag{2.3}$$

$$\nabla \cdot \vec{E} = 0 \tag{2.4}$$

combine to give the vector Helmholtz equations

$$\nabla^{2} \vec{E} = - \gamma^{2} \vec{E}$$

$$\nabla^{2} \vec{H} = - \gamma^{2} \vec{H}$$

where

$$\gamma^2 = j\omega\mu\sigma - \omega^2\mu\varepsilon \tag{2.5}$$

In rectangular cartesian coordinates, this vector equation separates, so that each of the components of the E and H fields satisfies the scalar Helmholtz equation. Elementary solutions to this equation are of the form

$$-(Y_x x + Y_y y + Y_z z)$$

where

$$Y_{x}^{2} + Y_{y}^{2} + Y_{z}^{2} = Y^{2} = j\omega\mu\sigma - \omega^{2}\mu\varepsilon$$
 (2.6)

The general solution is obtained by summing various elementary solutions with different values of A, Y_x , Y_y , and Y_z , subject to the constraints of equation (2.6). Returning for the moment to an elementary solution, if the coordinate axes are aligned such that positive z is down, and the direction of propagation is in the x-z plane, then the elementary solution is of the form

$$Ae^{-Y_{x}^{x} - Y_{z}^{z}}; Y_{x}^{2} + Y_{z}^{2} = Y^{2}$$
 (2.7)

Thus, for a homogeneous plane electromagnetic wave with its direction of propagation in the x-z plane, each of the components of E and H will be of the form shown in (2.7).

Since any homogeneous plane wave can be separated into TE (horizontal E field only) and TM (horizontal H field only) modes, and since the equations are linear with respect to the fields, one can consider the two modes separately.

For the TE mode,

$$E_{x} = E_{z} = 0$$

and equation (2.1) becomes

$$-\frac{\partial E}{\partial z} + \overline{k} \frac{\partial E}{\partial x} = -j\omega \mu (\overline{i} H_x + \overline{j} H_y + \overline{k} H_z)$$

Thus

$$Y_z E_y = -j\omega\mu H_x$$
$$-Y_x E_y = -j\omega\mu H_z$$
$$H_y = 0$$

In particular,

$$Z_{TE} = -\frac{E_{Y}}{H_{x}} = \frac{j\omega\mu}{Y_{z}} \qquad (2.8)$$

For the TM mode,

$$H_x = H_z = 0$$

and equation (2.2) becomes

$$-\frac{\partial H}{\partial x} + \frac{\partial H}{\partial x} = (\sigma + j\omega\varepsilon)(\overline{i}E_x + \overline{j}E_y + \overline{k}E_z)$$

Thus

$$Y_z H_y = (\sigma + j\omega \epsilon) E_x$$

$$-Y_x H_y = (\sigma + j\omega \epsilon) E_z$$

$$E_y = 0$$

and

$$Z_{TM} = \frac{E_{x}}{H_{y}} = \frac{Y_{z}}{(\sigma + j\omega \epsilon)} = \frac{j\omega \mu Y_{z}}{Y^{2}}$$
 (2.9)

For the range of parameters normally encountered in magnetotelluric work, displacement currents in the earth can be neglected. That is to say

$$\omega \in \langle \langle \sigma \rangle \rangle$$
 (2.10)

so that

$$Y^2 = j\omega\mu\sigma \tag{2.11}$$

Continuity of the tangential fields at the surface $\mathbf{z} = \mathbf{0}$ requires that

$$Y_{x \text{ air}} = Y_{x \text{ earth}}$$
 (2.12)

For a plane wave striking the earth at a real angle $\boldsymbol{\theta}$ measured from normal incidence,

$$Y_{x \text{ air}} = j\omega \sqrt{\mu \varepsilon} \sin \theta$$
 (2.13)

Equation (2.10), (2.12) and (2.13) together imply that

 $|\gamma_{x}|^{2} << |\gamma|^{2}$. Therefore one may take

$$Y_{z} = Y = \sqrt{j\omega\mu\sigma}$$
 (2.14)

Under these conditions, equations (2.8) and (2.9) give

$$Z_{TE} = Z_{TM} = \sqrt{\frac{j\omega u}{\sigma}}$$
 (2.15)

This implies that the impedance is independent of the polarization of the elementary solution. Thus, any general solution made up of elementary solutions satisfying the conditions of equation (2.14) will give a scalar impedance

$$Z = \sqrt{\frac{j\omega\mu}{\sigma}}$$
 (2.16)

which will relate any horizontal component of the total H field to the orthogonal horizontal component of the E field.

Actually it is not necessary to restrict the general solution for the incident fields to modes corresponding to real angles of incidence, as indicated by equation (2.13). Elementary solutions for which $|\gamma_{\rm x}|^2 > \omega^2 \mu^{\epsilon}$ will still give rise to total fields which satisfy equation (2.16) provided

$$|\gamma_{x}|^{2} << \omega \mu \sigma \tag{2.17}$$

It is convenient to define a parameter δ , called skin depth, for conductive materials by

$$\delta = \sqrt{2/\omega\mu\sigma} \tag{2.18}$$

Then

$$e^{-\frac{\gamma}{2}z} = e^{-(\hat{\mathbf{i}}+\hat{\mathbf{j}})z/\delta}$$
 (2.19)

Thus δ is a measure of the depth that an electromagnetic field will penetrate into a conductive medium. It is the depth at which the field will have been attenuated to 1/e of its surface value.

 $\label{eq:linear_loss} \mbox{If one then defines the horizontal wavelength λ of an elementary} \\ \mbox{solution by}$

$$\lambda = \frac{2\pi}{k_x}$$
; $jk_x = \gamma_x$

then a statement that is equivalent to equation (2.17) is that

$$\lambda >> \delta \tag{2.20}$$

In other words, the horizontal wavelength is long compared to the skin depth.

In summary then, for an earth model consisting of a homogeneous half space of conductivity σ , with incident fields having horizontal wavelengths long compared to a skin depth, the surface impedance will be given by equation (2.16).

B. Horizontally Layered Model

The next model that might be considered is one in which the earth is represented by a sc. of horizontal layers, each with a different conductivity. This is usually known as the Cagniard model since it is the one that he considered in his classic paper. One assumes N layers, as shown in figure 1, and assumes elementary solutions in each layer of the form

$$(A_i e^{-\gamma_{zi}^z} + B_i e^{\gamma_{zi}^z}) e^{-\gamma_{xi}^x}$$

where

$$\gamma_{xi}^{2} + \gamma_{zi}^{2} = \gamma_{i}^{2} = j\omega\mu\sigma_{i}$$
 (2.21)

By requiring that the tangential fields be continuous at each boundary, and noting that $B_N=0$ since the fields must vanish for large z, one finds that the impedance Z, looking down from the top of the ith layer is given by

$$Z_{i} = Z_{0i} \frac{1 - R_{i} e^{-2Y_{zi}d_{i}}}{1 + R_{i} e^{-2Y_{zi}d_{i}}}; i = 1, 2, ... N-1$$
(2.22)

$$z_N = z_{oN}$$

where d_i is the thickness of the ith layer, R_i is a reflection coefficient defined by

$$R_{i} = \frac{Z_{0i} - Z_{i+1}}{Z_{0i} + Z_{i+1}}$$
 $i = 1, 2, ... N-1$ (2.23)

and \mathbf{Z}_{oi} is the characteristic impedance of the ith layer. As with the homogeneous half space, the characteristic impedance for the TE mode is

$$Z_{\text{oi}}^{\text{TE}} = j\omega\mu/\gamma_{\text{zi}} \tag{2.24}$$

and for the TM mode is

$$Z_{0i}^{TM} = j\omega\mu \gamma_{zi}/\gamma_i^2 \qquad (2.25)$$

Again if one assumes that the horizontal wavelengths of the incident fields are long compared to a skin depth in each layer, the two modes become equivalent and

$$Z_{Qi} = \sqrt{j\omega\mu/\sigma_i} \tag{2.26}$$

In either case, one may start at the bottom layer and work up, computing R_i and Z_i using the recursion equations (2.23) and (2.22) until Z_l , the surface impedance, is obtained.

Recall from equation (2.16) that for a homogeneous half space

$$\sigma = \frac{\omega \mu}{|z|^2}$$

Correspondingly, for a layered model, it is customary to define an apparent conductivity $\sigma_a(\omega)$ or apparent resistivity $\rho_a(\omega)$ by

$$\sigma_{\mathbf{a}}(\omega) = \frac{\omega u}{|z_{1}(\omega)|^{2}} = \frac{1}{\rho_{\mathbf{a}}(\omega)}$$
 (2.27)

Some sample curves of apparent resistivity versus frequency for several models are plotted in figures 2 and 3. For high frequencies, $\sigma_a = \sigma_1$, and for low frequencies, $\sigma_a = \sigma_N$. Qualitatively it appears that $\sigma_a(w)$ is a "smoothed out" version of $\sigma(z)$ with frequency w being inversely related to depth z.

Although it is a simple matter to obtain the surface impedance $Z_1(\omega)$ in terms of $\sigma(z)$ for any layered model, the inverse problem of finding $\sigma(z)$ for a specified $Z_1(\omega)$ is not so simple. It is a nonlinear problem that in general can be solved only by using iterative techniques. Computer programs are available for least squares fitting $Z(\omega)$ curves to N layer models (Patrick, 1969).

Since $\sigma_a(w)$ is a smooth curve, one might suspect that fine details in $\sigma(z)$ cannot be determined from $\sigma_a(w)$. This in fact turns out to be the case; only gross trends in $\sigma(z)$ can successfully be determined from $\sigma_a(w)$.

C. General One Dimensional Model

Consider the case where $\sigma(z)$ is a continuously varying function of z rather than being restricted to a finite number of homogeneour layers. In this case, the recursion equations (2.22) and (2.23) are replaced by a differential equation for Z. There are several ways to obtain the differential equation. One way is to combine the recursion equations (2.22) and (2.23), and let Δz replace d_i , and consider the limit as Δz approaches zero. Another simpler method pointed out by Swift (1967) uses Maxwell's equations directly. Consider the TE mode with $E_x = E_z = 0$. Equations (2.1) and (2.2) give

$$\frac{\partial E}{\partial z} = j\omega \mu H_{x}$$

$$\frac{\partial E}{\partial x} = -j\omega \mu H_{z}$$

$$\sigma E_{y} = -\frac{\partial H}{\partial x} + \frac{\partial H}{\partial z}$$

Now

$$\begin{split} Z_{\text{TE}} &= -\frac{E_{y}}{H_{x}} \\ \frac{\partial Z_{\text{TE}}}{\partial z} &= -\frac{1}{H_{x}} \frac{\partial E_{y}}{\partial z} + \frac{E_{y}}{H_{x}^{2}} \frac{\partial H_{x}}{\partial z} \\ &= -\frac{1}{H_{x}} \left[j \omega \mu H_{x} \right] + \frac{E_{y}}{H_{x}^{2}} \left[\sigma E_{y} + \frac{\partial H_{z}}{\partial x} \right] \\ &= -j \omega \mu + \frac{E_{y}}{H_{x}^{2}} \left[\sigma E_{y} - \frac{1}{j \omega \mu} \frac{\partial^{2} E_{y}}{\partial x^{2}} \right] \\ &= -j \omega \mu + \sigma Z_{\text{TE}}^{2} - \frac{\gamma_{x}^{2}}{j \omega \mu} Z_{\text{TE}}^{2} \end{split}$$

$$\frac{\partial Z_{TE}}{\partial z} = -j\omega\mu + (1 - \frac{\gamma_x^2}{\gamma^2}) \sigma Z_{TE}^2 \qquad (2.28)$$

Similarly for the TM mode one obtains

$$\frac{\partial Z_{TM}}{\partial z} = -j\omega\mu \left(1 - \frac{\gamma^2}{x^2}\right) + \sigma Z_{TM}^2$$
 (2.29)

Again when the incident fields have horizontal wavelengths large compared to a skin depth, the TE and TM modes become equivalent and

$$\frac{\partial Z}{\partial z} = -j\omega\mu + \sigma Z^2 \tag{2.30}$$

This differential equation is of course nonlinear in Z; however, if one assumes a $\sigma(z)$ profile such that $\sigma(z) = \sigma_1$, a constant for $z > z_1$, then $Z(z_1) = \sqrt{j\omega\mu/\sigma_1}$ and equation (2.30) can be numerically integrated from $z = z_1$ to z = 0 to obtain an expression for the surface impedance in terms of the conductivity profile.

Thus, as with the layered model, the forward going problem of finding the surface impedance in terms of a specified conductivity profile is relatively simple. Again, the inverse problem of finding the $\sigma(z)$ profile which produces a specified surface impedance must be worked iteratively.

D. Linearized One Dimensional Model

Consider the following simplification of the one dimensional problem. Assume that the E field as a function of depth ${\bf z}$ has the form

$$E_{x}(z) = Ae^{-\sum_{0}^{z} Y(z') dz'}$$
(2.31)

where A is independent of z and

$$Y(z) = \sqrt{j\omega\mu\sigma(z)}$$
 (2.32)

From Maxwell's equations

$$\frac{dH}{dz} = -\sigma E_{x}$$

Integrating with respect to z and noting that $H_{_{\mbox{\scriptsize V}}}$ must vanish as $z \to \infty$, one has

$$\int_{0}^{\infty} \frac{dH}{dz} dz = -\int_{0}^{\infty} \sigma E_{x} dz$$

or

$$H_{y}(\infty) - H_{y}(0) = -\int_{0}^{\infty} \sigma(z) Ae^{-\int_{0}^{z} \gamma(z') dz'} dz$$

Thus, if one defines the surface admittance $Y(\omega)$ as being the reciprocal of the surface impedance, then

$$Y(\omega) = \frac{H_{y}(z=o)}{E_{x}(z=o)} = \int_{0}^{\infty} \sigma(z) e^{-\int_{0}^{z} Y(z') dz'} dz$$
 (2.33)

or, from equation (2.32)

$$Y(\omega) = \int_{0}^{\infty} \sigma(z) e$$

$$z = \sqrt{j\omega\mu} \int_{0}^{z} \sqrt{\sigma(z')} dz' dz$$

$$(2.34)$$

Now consider the following transformation. Let

$$e^{\alpha_1} = \int_{0}^{z} \sqrt{\sigma(z')} dz' \qquad (2.35)$$

and

$$e^{-\alpha_2} = \sqrt{\omega \mu/2} \tag{2.36}$$

Noting that

$$e^{\alpha_1} d\alpha_1 = \sqrt{\sigma(z)} dz \qquad (2.37)$$

and

$$z = o \rightarrow \alpha_1 = -\infty$$

$$z = \infty \rightarrow \alpha_1 = \infty$$

equation (2.34) becomes

$$Y(\alpha_2) = \int_{-\infty}^{\infty} \sqrt{\sigma(\alpha_1)} e^{-(1+j)} e^{(\alpha_1 - \alpha_2)} e^{\alpha_1} d\alpha_1$$

or

$$Y(\alpha_2) e^{-\alpha_2} = \int_{-\infty}^{\infty} \sqrt{\sigma(\alpha_1)} e^{-(1+j)} e^{-(\alpha_2 - \alpha_1)} e^{-(\alpha_2 - \alpha_1)} d\alpha_1$$
 (2.38)

Noting from equation (2.27) that

$$\sqrt{\sigma_{a}(\omega)} = \sqrt{\omega \mu} | Y(\omega) |$$

equation (2.38) gives

$$\sqrt{\sigma_{a}(\alpha)} = |\sqrt{\sigma(\alpha)} * g(\alpha)| \qquad (2.39)$$

where

$$g(\alpha) = \sqrt{2} e^{-(1+j)} e^{-\alpha} e^{-\alpha}$$
 (2.40)

Thus, under this simplified model, which in effect neglects internal reflections in the E field, the apparent conductivity can be obtained by convolving the actual conductivity profile with a complex linear response

function in α -space. A plot of the magnitude of $g(\alpha)$ versus α is shown in figure 4. The magnitude of $g(\alpha)$ peaks up at $\alpha=0$ and decays as $|\alpha|$ increases. Also

$$\left|\int_{-\infty}^{\infty} g(\alpha) d\alpha\right| = 1$$

So $g(\alpha)$, although it is complex, is somewhat like the response of a low pass filter with unity DC gain. This is consistent with the earlier observation that $\sigma_a(\omega)$ is a "smoothed out" version of $\sigma(z)$ with ω inversely related to z.

In practice, this simplified approach is probably not very useful by itself since the assumed form of the E field in equation (2.31) is not too realistic. Strictly speaking it is valid only if

$$\left|\frac{d\sigma(z)}{dz}\right| << \gamma(z) \sigma(z) \tag{2.41}$$

for all z. On the other hand this approach could be quite useful for obtaining a first guess to be used in an iterative inversion scheme. In particular if one simply assumes that

$$\sigma(\alpha) \cong \sigma_{\alpha}(\alpha)$$
 (2.42)

then frequency and depth may be related through equations (2.35) and (2.36) to give

$$\sigma(z) \cong \sigma_{a}(z_{a}(\omega))$$
 (2.43)

where

$$z_{a}(\omega) = \int_{\omega}^{\infty} \frac{d\omega_{o}}{\sqrt{2\omega_{o}^{3}\mu\sigma_{a}(\omega_{o})}}$$
 (2.44)

Thus, an approximate depth scale may be attached to the frequency scale for an apparent conductivity curve. Notice that for $\sigma_a(w) = \sigma$, a constant, equation (2.44) reduces to the standard skin depth, so one may think of $z_a(w)$ as sort of an integrated skin depth. In fact, for cases where equation (2.41) is satisfied, $z_a(w)$ will be the depth at which the fields have decayed to 1/e of their surface value.

E. Generalized Skin Depth

As suggested by the preceding paragraph, it will be useful to generalize the idea of skin depth for an inhomogeneous model. For a homogeneous medium, the skin depth was defined to be the depth at which the fields are attenuated to 1/e of their surface values. For an inhomogeneous model, the fields of course do not have a simple exponential decay; however, if one defines $\delta(\omega)$ to be the depth at which

$$\operatorname{Re}\left[\int_{0}^{\delta(w)} \sqrt{j w u \sigma(z)} \, dz\right] = 1 \tag{2.45}$$

then δ will be a good measure of the depth of penetration of the fields and as such it may be taken as the skin depth.

In the discussion of the horizontally layered model, the statement was made that the incident fields could be treated as normally incident plane waves if the actual horizontal wavelengths were long compared to a skin depth in each layer since for that case

$$\gamma_{zi} \cong \gamma_{i}$$

A less restrictive yet adequate requirement is that

$$\int_{0}^{\delta} Y_{z} dz \approx \int_{0}^{\delta} Y dz$$
 (2.46)

where δ is defined by equation (2.45). Clearly this condition will exist provided

$$\begin{vmatrix} \delta \\ \gamma_{x} dz \end{vmatrix} \ll \begin{vmatrix} \delta \\ \gamma dz \end{vmatrix} \tag{2.47}$$

where $\gamma_x^2 + \gamma_z^2 = \gamma^2 = j\omega\mu\sigma$. But $\gamma_x = jk_x = j2\pi/\lambda$. Thus

$$\left| \int_{0}^{\delta} \gamma_{x} dz \right| = \frac{2\pi\delta}{\lambda}$$
 (2.48)

Also, from equation (2.45), the definition of δ ,

$$\begin{vmatrix} \delta \\ \zeta \\ \gamma \\ dz \end{vmatrix} = \sqrt{2}$$

Thus, the condition (2.47) will exist provided

$$\frac{2\pi\delta}{\lambda} << \sqrt{2}$$

or

$$\delta << \lambda / \sqrt{2\pi}$$

So, if the horizontal wavelengths are long compared to the skin depth defined by equation (2.45), the incident fields may in effect be treated as normally incident plane waves.

In conclusion then, the forward going one dimensional problem is reasonably simple. If the incident fields are assumed to have horizontal wavelengths long compared to a skin depth, then any horizontal component of the H field is related to the orthogonal horizontal component of the E

field by a scalar impedance which is related to the conductivity profile. The inverse problem of estimating the conductivity profile from a measured surface impedance, while it is nonlinear has been worked with some success using iterative techniques. The simple linearized model discussed here should be useful for providing a first guess for such iterative solutions.

III. TWO AND THREE DIMENSIONAL MODELS

The scalar surface impedance discussed in the previous chapter is not sufficient to describe the relationship between the horizontal E and H fields for a model that has lateral variations in conductivity. In this chaper some general relationships will be developed for two dimensional models (models for which σ is a function of two space coordinates, the vertical or z coordinate and one horizontal coordinate, say x) and for three dimensional models (models for which σ is a function of all three space coordinates). It will be shown that for these models the impedance must be expressed as a rank two tensor as was indicated in equation (1.1).

A. \mathbf{Z}_{TE} and \mathbf{Z}_{TM} for Two Dimensional Models

Consider again Maxwell's equations as stated in equations (2.1) through (2.4). If one assumes that the conductivity σ is a function of x and z, equations (2.1) through (2.3) are still applicable; however, equation (2.4) must be replaced by

$$\nabla \cdot (\sigma E) = 0 \tag{3.1}$$

where once again it is assumed that displacement currents in the earth are negligible. If one also assumes once again that the horizontal wavelengths of the incident fields are long compared to a skin depth, then in the earth, everything is essentially uniform in the y direction so that equations (2.1) through (2.3) together with equation (3.1) in component form become

$$-\frac{\partial E_{y}}{\partial z} = -j\omega\mu H_{x}$$
 (3.2)

$$\frac{\partial E}{\partial z} - \frac{\partial E}{\partial x} = -j\omega\mu H_y$$
 (3.3)

$$\frac{\partial E}{\partial x} = j\omega \mu H_z \tag{3.4}$$

$$-\frac{\partial H}{\partial z} = \sigma E_{x} \tag{3.5}$$

$$\frac{\partial H_{X}}{\partial z} - \frac{\partial H_{Z}}{\partial x} = \sigma E_{y}$$
 (3.6)

$$\frac{\partial H}{\partial x} = \sigma E_z \tag{3.7}$$

$$\frac{\partial x}{\partial H^{X}} + \frac{\partial x}{\partial Z} = 0 \tag{3.8}$$

$$\frac{\partial(\sigma E)}{\partial x} + \frac{\partial(\sigma E)}{\partial z} = 0 \tag{3.9}$$

Observe that the only field components involved in equations (3.2), (3.4), (3.6), and (3.8) are E_y , H_x , and H_z . Also, the only components entering equations (3.3), (3.5), (3.7), and (3.9) are E_x , E_z , and H_y . Thus it is apparent that the two modes are decoupled and may be considered separately. The mode involving E_y , H_x , and H_z is usually called the TE or E parallel mode since the E field is horizontal and parallel to the strike. The mode involving E_x , E_z , and H_y is called the TM or E perpendicular mode since the magnetic field is horizontal and the electric field is perpendicular to the strike. The strike is the direction along which there are no variations in the model parameters, in this case, the y direction.

Thus, for a two-dimensional model two impedances are required to define the relationship between the horizontal components of the E and H fields: $Z_{TE} = -E_y/H_x$ and $Z_{TM} = E_x/H_y$. Exact solutions for $Z_{TE}(w,x)$ and $Z_{TM}(w,x)$ in terms of $\sigma(x,z)$ are not tractable analytically although a few approximate cases have been worked out. In general, solutions are obtainable only by using numerical methods such as finite differencing over a two dimensional grid. Computer programs are available which implement these

techniques (Patrick, 1969). It would appear that the inverse problem of finding $\sigma(x,z)$ in terms of $Z_{TE}(\omega,x)$ and $Z_{TM}(\omega,x)$ could in principle be solved using iterative techniques similar to those used for the one dimensional inverse problem. It is believed that such a solution would be unique, although no proof is known. On the other hand, the number of calculations involved for grids large enough to be of interest is so great that the problem seems to be out of the range of present day computers. Nevertheless, useful and instructive information about two dimensional modeling can be obtained from solutions of the forward going problem.

B. Z in a General Coordinate System for Two Dimensional Models
As was shown above, for a two dimensional model the TE and TM
modes decouple when one of the horizontal coordinates is aligned with the
strike. It will now be useful to obtain the relationship between the tangential
fields in a coordinate system in which the horizontal axes are arbitrarily
oriented.

Suppose that the x' - y' coordinate system as shown in figure 5 is aligned with the strike, so that

$$E'_{x} = Z_{TM} H'_{y}$$
 (3.10)

and

$$E'_{v} = -Z_{TE} H'_{x}$$
 (3.11)

Suppose that the x-y coordinate system is oriented at an angle θ with respect to the x'-y' system as shown in figure 5. Then

$$E_{x} = E'_{x} \cos \theta + E'_{y} \sin \theta \qquad (3.12)$$

$$E_{v} = -E'_{x} \sin \theta + E'_{y} \cos \theta \qquad (3.13)$$

and

$$H_{X} = H'_{X}\cos\theta + H'_{Y}\sin\theta \qquad (3.14)$$

$$H_{y} = -H_{x}' \sin \theta + H_{y}' \cos \theta \qquad (3.15)$$

or alternately

$$H'_{x} = H_{x} \cos \theta - H_{y} \sin \theta$$
 (3.16)

$$H'_{v} = H_{x} \sin \theta + H_{y} \cos \theta \qquad (3.17)$$

Combining these equations gives

$$\begin{split} \mathbf{E}_{\mathbf{x}} &= \mathbf{E}_{\mathbf{x}}^{'} \cos \theta + \mathbf{E}_{\mathbf{y}}^{'} \sin \theta \\ &= (\mathbf{Z}_{\mathbf{TM}} \mathbf{H}_{\mathbf{y}}^{'}) \cos \theta + (-\mathbf{Z}_{\mathbf{TE}} \mathbf{H}_{\mathbf{x}}^{'}) \sin \theta \\ &= \mathbf{Z}_{\mathbf{TM}}^{'} (\mathbf{H}_{\mathbf{x}} \sin \theta + \mathbf{H}_{\mathbf{y}} \cos \theta) \cos \theta - \mathbf{Z}_{\mathbf{TE}}^{'} (\mathbf{H}_{\mathbf{x}} \cos \theta - \mathbf{H}_{\mathbf{y}} \sin \theta) \sin \theta \\ &= \mathbf{H}_{\mathbf{x}}^{'} [(\mathbf{Z}_{\mathbf{TM}}^{'} - \mathbf{Z}_{\mathbf{TE}}^{'}) \sin \theta \cos \theta] + \mathbf{H}_{\mathbf{y}}^{'} [\mathbf{Z}_{\mathbf{TM}}^{'} \cos^{2} \theta + \mathbf{H}_{\mathbf{y}}^{'} (\mathbf{Z}_{\mathbf{TM}}^{'} \cos^{2} \theta)] \end{split}$$

Thus if one defines

$$E_x = Z_{xx} H_x + Z_{xy} H_y$$

then

$$Z_{xx} = (Z_{TM} - Z_{TE}) \sin \theta \cos \theta$$
$$= \left(\frac{Z_{TM} - Z_{TE}}{2}\right) \sin 2 \theta$$

and

$$Z_{xy} = Z_{TM} \cos^2 \theta + Z_{TE} \sin^2 \theta$$
$$= \left(\frac{Z_{TM} + Z_{TE}}{2}\right) + \left(\frac{Z_{TM} - Z_{TE}}{2}\right) \cos 2\theta$$

Similarly for the other components, one obtains

$$Z_{yx} = -\left(\frac{Z_{TM} + Z_{TE}}{2}\right) + \left(\frac{Z_{TM} - Z_{TE}}{2}\right) \cos 2\theta$$

and

$$Z_{yy} = \left(\frac{Z_{TE} - Z_{TM}}{2}\right) \sin 2\theta$$

In summary

$$\begin{bmatrix} \mathbf{E}_{\mathbf{x}} \\ \mathbf{E}_{\mathbf{y}} \end{bmatrix} = \begin{bmatrix} \mathbf{Z}_{1} \sin 2\theta & \mathbf{Z}_{2} + \mathbf{Z}_{1} \cos 2\theta \\ -\mathbf{Z}_{2} + \mathbf{Z}_{1} \cos 2\theta & -\mathbf{Z}_{1} \sin 2\theta \end{bmatrix} \begin{bmatrix} \mathbf{H}_{\mathbf{x}} \\ \mathbf{H}_{\mathbf{y}} \end{bmatrix}$$
(3.18)

where

$$Z_{1} = (Z_{TM} - Z_{TE})/2 (3.19)$$

$$Z_2 = (Z_{TM} + Z_{TE})/2$$
 (3.20)

In general, then, for a two dimensional model, the tangential components of E and H are related by a rank two tensor impedance. The diagonal terms of the Z matrix are in general negatives of each other and they reduce to zero when the axes are aligned with the strike.

C. General Form of Z for Three Dimensional Models

For three dimensional models where σ is a function of all three space coordinates, the six field components are in general all coupled to each other, so it is not possible to separate the analysis into two distinct modes as was done for the two dimensional case. Nevertheless, it is possible to make some general statements about the relationship between the tangential components of the E and H fields.

It will now be shown that a rank two tensor impedance of the form shown in equation (1.1) is unique and stable, subject once again of course to the assumption that the horizontal wavelengths of the incident fields are long compared to a skin depth in the earth. Also it will be useful for later purposes to establish that in general the vertical magnetic field can be expressed as a linear combination of the two horizontal H field components. That is,

$$H_z = r_{zx} H_x + r_{zy} H_y$$
 (3.21)

where r_{zx} and r_{zy} are dimensionless constants, subject also of course to the assumption that the incident fields have horizontal wavelengths long compared to a skin depth. This assumption implies that the incident fields may be treated as normally incident plane waves. This being the case, the incident fields can be separated into two orthogonal linearly polarized plane waves. Clearly, for a linearly polarized normally incident plane wave, each of the components of the total E and H fields will be proportional to the amplitude of the incident wave. Thus, if the incident E is linearly polarized in the x direction then

$$E_{x} = a_{1} E_{xi}$$

$$E_{y} = a_{2} E_{xi}$$

$$H_{x} = b_{1} E_{xi}$$

$$H_{y} = b_{2} E_{xi}$$

$$H_{z} = c_{1} E_{xi}$$

where $\mathbf{E}_{\mathbf{x}i}$ is the incident field. Similarly, if the incident E is linearly polarized in the y direction

$$E_{x} = a_{3} E_{yi}$$

$$E_{y} = a_{4} E_{yi}$$

$$H_{x} = b_{3} E_{yi}$$

$$H_{y} = b_{4} E_{yi}$$

$$H_{z} = c_{2} E_{yi}$$

Since all of the field equations are linear with respect to E and H, superposition must hold. Thus for a general normally incident plane wave

$$E_x = a_1 E_{xi} + a_3 E_{yi}$$

$$E_{y} = a_{2}E_{xi} + a_{4}E_{yi}$$

$$H_{x} = b_{1}E_{xi} + b_{3}E_{yi}$$

$$H_{y} = b_{2}E_{xi} + b_{4}E_{yi}$$

$$H_{z} = c_{1}E_{xi} + c_{2}E_{yi}$$

or in matrix notation

$$\begin{bmatrix} E_{x} \\ E_{y} \end{bmatrix} = \begin{bmatrix} A \end{bmatrix} \begin{bmatrix} E_{xi} \\ E_{yi} \end{bmatrix}$$

$$\begin{bmatrix} H_{\mathbf{x}} \\ H_{\mathbf{y}} \end{bmatrix} = \begin{bmatrix} B \end{bmatrix} \begin{bmatrix} E_{\mathbf{x}i} \\ E_{\mathbf{y}i} \end{bmatrix}$$

and

$$H_{z} = [C] \begin{bmatrix} E_{xi} \\ E_{yi} \end{bmatrix}$$

If [B] is nonsingular, then

$$\begin{bmatrix} E_{xi} \\ E_{yi} \end{bmatrix} = \begin{bmatrix} B^{-1} \\ H_{y} \end{bmatrix}$$

so that

$$\begin{bmatrix} E_{x} \\ E_{y} \end{bmatrix} = [A][B]^{-1} \begin{bmatrix} H_{x} \\ H_{y} \end{bmatrix}$$

and

$$H_{z} = [C][B]^{-1} \begin{bmatrix} H_{x} \\ H_{y} \end{bmatrix}$$
 (3.22)

Thus

$$[Z] = [A][B]^{-1}$$
 (3.23)

and

$$[r] = [r_{2x}, r_{2y}] = [C][B]^{-1}$$
 (3.24)

So [Z] and [r] are defined, and E_x , E_y and H_z can be expressed as linear combinations of H_x and H_y . The only problem that might arise would be if [B] were singular. Singularity of [B] implies that

$$b_1 b_4 = b_2 b_3 \tag{3.25}$$

Now for any reasonable earth model, the reflection coefficient for the magnetic field at the surface is almost unity so that the total H field is close to twice the incident field. Thus, a normally incident plane wave with E linearly polarized in the x direction (and hence H linearly polarized in the y direction) will give rise to total fields such that H_y will be considerably greater than H_x . Thus

Similarly, for a normally incident plane wave with E linearly polarized in the y direction, H_{χ} will be somewhat greater than H_{χ} . Thus

So clearly

Comparing this with equation (3.25) indicates that for any reasonable earth model, [B] will not be singular, and hence Z is defined by equation (3.23).

Next it will be useful to observe the behavior of the elements of Z as the coordinate system is rotated. As with the two dimensional model,

the elements of Z in the x-y coordinate system will be expressed in terms of the elements of Z in the x'-y' coordinate system as shown in figure 5. The derivation is the same as for the two dimensional case except that equations (3.10) and (3.11) are replaced by

$$E'_{x} = Z'_{xx} H'_{x} + Z'_{xy} H'_{y}$$
 (3.26)

and

$$E'_{y} = Z'_{yx} H'_{x} + Z'_{yy} H'_{y}$$
 (3.27)

Thus

$$\begin{split} E_{\mathbf{x}} &= E_{\mathbf{x}}^{'} \cos \theta + E_{\mathbf{y}}^{'} \sin \theta \\ &= (Z_{\mathbf{x}\mathbf{x}}^{'} H_{\mathbf{x}}^{'} + Z_{\mathbf{x}\mathbf{y}}^{'} H_{\mathbf{y}}^{'}) \cos \theta + (Z_{\mathbf{y}\mathbf{x}}^{'} H_{\mathbf{x}}^{'} + Z_{\mathbf{y}\mathbf{y}}^{'} H_{\mathbf{y}}^{'}) \sin \theta \\ &= (Z_{\mathbf{x}\mathbf{x}}^{'} \cos \theta + Z_{\mathbf{y}\mathbf{x}}^{'} \sin \theta) H_{\mathbf{x}}^{'} + (Z_{\mathbf{x}\mathbf{y}}^{'} \cos \theta + Z_{\mathbf{y}\mathbf{y}}^{'} \sin \theta) H_{\mathbf{y}}^{'} \\ &= (Z_{\mathbf{x}\mathbf{x}}^{'} \cos \theta + Z_{\mathbf{y}\mathbf{x}}^{'} \sin \theta) (H_{\mathbf{x}} \cos \theta - H_{\mathbf{y}} \sin \theta) \\ &+ (Z_{\mathbf{x}\mathbf{y}}^{'} \cos \theta + Z_{\mathbf{y}\mathbf{y}}^{'} \sin \theta) (H_{\mathbf{x}} \sin \theta + H_{\mathbf{y}} \cos \theta) \\ &+ (Z_{\mathbf{x}\mathbf{y}}^{'} \cos \theta + Z_{\mathbf{y}\mathbf{y}}^{'} \sin \theta) (H_{\mathbf{x}} \sin \theta + H_{\mathbf{y}} \cos \theta) \\ &= [Z_{\mathbf{x}\mathbf{x}}^{'} \cos^{2} \theta + Z_{\mathbf{y}\mathbf{y}}^{'} \sin^{2} \theta + (Z_{\mathbf{y}\mathbf{x}}^{'} + Z_{\mathbf{x}\mathbf{y}}^{'}) \sin \theta \cos \theta] H_{\mathbf{x}} \\ &+ [Z_{\mathbf{x}\mathbf{y}}^{'} \cos^{2} \theta - Z_{\mathbf{y}\mathbf{x}}^{'} \sin^{2} \theta + (Z_{\mathbf{y}\mathbf{y}}^{'} - Z_{\mathbf{x}\mathbf{x}}^{'}) \sin \theta \cos \theta] H_{\mathbf{y}} \end{split}$$

So that

$$Z_{xx} = Z'_{xx} \cos^2 \theta + Z'_{yy} \sin^2 \theta + (Z'_{xy} + Z'_{yx}) \sin \theta \cos \theta$$

$$\left(\frac{Z'_{xx} + Z'_{yy}}{2}\right) + \left(\frac{Z'_{xx} - Z'_{yy}}{2}\right) \cos 2 \theta + \left(\frac{Z'_{xy} + Z'_{yx}}{2}\right) \sin 2 \theta$$

Similar expressions for $\mathbf{Z}_{\mathbf{x}\mathbf{y}}$, $\mathbf{Z}_{\mathbf{y}\mathbf{x}}$, and $\mathbf{Z}_{\mathbf{y}\mathbf{y}}$ are obtained. The results are

$$Z_{xx} = Z_1 + Z_2 \cos 2\theta + Z_3 \sin 2\theta$$
 (3.28)

$$Z_{xy} = Z_4 + Z_3 \cos 2\theta - Z_2 \sin 2\theta$$
 (3.29)

$$Z_{yx} = -Z_4 + Z_3 \cos 2\theta - Z_2 \sin 2\theta$$
 (3.30)

$$Z_{vv} = Z_{i} - Z_{2} \cos 2\theta - Z_{3} \sin 2\theta$$
 (3.31)

where

$$z_{1} = \frac{z'_{xx} + z'_{yy}}{2}$$
 (3.32)

$$Z_{2} = \frac{Z'_{xx} - Z'_{yy}}{2}$$
 (3.33)

$$Z_3 = \frac{Z'_{xy} + Z'_{yx}}{2}$$
 (3.34)

$$Z_{4} = \frac{Z'_{xy} - Z'_{yx}}{2} \tag{3.35}$$

If one further defines

$$Z_{O}(\theta) = Z_{3} \cos 2\theta - Z_{2} \sin 2\theta \qquad (3.36)$$

Then equations (3.28) through (3.31) become

$$Z_{xx} = Z_1 - Z_0(\theta + 45^{\circ})$$
 (3.37)

$$Z_{xy} = Z_4 + Z_0(\theta) \tag{3.38}$$

$$Z_{vx} = -Z_4 + Z_0(\theta)$$
 (3.39)

$$Z_{yy} = Z_1 + Z_0(e + 45^\circ)$$
 (3.40)

The function $Z_0(\theta)$ traces an ellipse in the complex plane centered on the origin as θ varies from zero to 180° . To show that this is true take

$$Z_0(\theta) = x + jy$$

where x and y are real. From equation (3.36)

$$x = \text{Re}[Z_3] \cos 2\theta - \text{Re}[Z_2] \sin 2\theta$$

$$= A \cos (2\theta - \alpha)$$

$$y = \text{Im}[Z_3] \cos 2\theta - \text{Im}[Z_2] \sin 2\theta$$

$$= B \cos (2\theta - \beta)$$

Ietting

$$2\theta - \alpha = \varphi$$

$$\beta - \alpha = \varphi_{\Omega}$$

gives

$$x = A \cos \phi$$

and

$$y = B \cos (\phi - \phi_0) = C \cos \phi + D \sin \phi$$

Thus

$$\cos \varphi = \frac{x}{A}$$

and

$$\sin \varphi = \pm \sqrt{1 - (x/A)^2}$$

So that

$$y = C \left[\frac{x}{A} \right] + D \left[\pm \sqrt{1 - (x/A)^2} \right]$$

or

$$y^2 - \frac{2C}{A}xy + \frac{C^2}{A^2}x^2 = D^2(1 - \frac{x^2}{A^2})$$

or

$$A^{2}y^{2} + (C^{2} + D^{2})x^{2} - 2ACxy - D^{2}A^{2} = 0$$

This is the standard form for an ellipse centered on the origin. Thus $Z_{O}(\theta)$ traces an ellipse in the complex plane as θ varies. Referring to equations (3.37) through (3.40) one observes that each of the elements of Z then traces an ellipse in the complex plane as the measuring axes are rotated.

D. Comparison of Z Matrix for Two and Three Dimensional Models As was shown in the previous section, for a three dimensional model, the elements of Z trace ellipses in the complex plane as the measuring axes are rotated. From equation (3.18) one observes that for two dimensional models, the theta dependent parts of the elements of Z have fixed phases. Thus the ellipses degenerate to straight lines for the two dimensional case. Also one observes from equation (3.18) that the diagonal terms of the Z matrix for the two dimensional case have no constant term. Thus the straight line representing the locii of Z_{xx} and Z_{yy} in the complex plane passes through the origin. Figure 6 illustrates the general form of the locii of the elements of Z in the complex plane for the two and three dimensional cases.

At the present time solutions for the general three dimensional problem are not available. For this reason, it is usually desirable to find one dimensional or two dimensional models that approximately fit measured data which in general is of course three dimensional. It frequently happens that, over some limited frequency range, measured data looks almost two dimensional; that is, the Z ellipses almost collapse to straight lines and the diagonal terms of the Z matrix are almost negatives of each other. This situation will occur whenever there exists a horizontal direction along which the conductivity cross section is nearly constant for a distance of several skin depths. Whenever this situation exists, it is desirable to determine the approximate strike direction and to estimate the corresponding Z_{TE} and Z_{TM} for comparison with theoretical Z's from two dimensional models.

Several methods have been proposed for estimating the principal impedance axes [Swift, 1967] all of which converge to the correct result when the data is actually two dimensional. From the point of view of the impedance ellipses, the most reasonable way seems to be to take

$$Z_{TE}$$
, $Z_{TM} = Z_4 \pm Z_0$ (3.41)

where Z_0' is the semi-major axis of the ellipse $Z_0(\theta)$ as defined in equation (3.36)

This method yields the principal directions as the values of θ which maximize $|Z_O(\theta)|$. A little algebra will show that these values of θ are given by the equation

$$\tan 4\theta = \frac{2(x_2 x_3 + y_2 y_3)}{(x_2^2 + y_2^2) - (x_3^2 + y_3^2)}$$
(3.42)

where \mathbf{x}_i and \mathbf{y}_i are the real and imaginary parts of \mathbf{Z}_i respectively, with \mathbf{Z}_i being defined by equations (3.33) and (3.34). Incidentally, this method gives the same result as Swift's method of finding the angle θ which maximizes $\{|\mathbf{Z}_{\mathbf{x}\mathbf{y}}|^2 + |\mathbf{Z}_{\mathbf{y}\mathbf{y}}|^2\}$ or minimizes $\{|\mathbf{Z}_{\mathbf{x}\mathbf{y}}|^2 + |\mathbf{Z}_{\mathbf{y}\mathbf{y}}|^2\}$.

Having thus obtained estimates of the principal axes of the impedance matrix and the corresponding principal impedance values, it is desirable to have some measure of how two dimensional the data actually is. To accomplish this, there are two parameters that should be considered. First, there is the ratio of the constant terms in the diagonal and off diagonal elements of the Z matrix. In other words, the ratio $\mathbf{Z}_1/\mathbf{Z}_4$ where \mathbf{Z}_1 and \mathbf{Z}_4 are defined in equations (3.32) and (3.35). Second, there is the ratio of the minor axis to the major axis of the $\mathbf{Z}_0(\theta)$ ellipse. The magnitudes of both of these ratios should be small compared to unity in order for the data to fit a two dimensional model.

E. Use of H_z for Determining the Strike Direction

In the previous section, an indication was given as to how one might estimate the principal axes of a measured impedance matrix which is approximately two dimensional. However, no method was given for determining which axis represents the strike direction. This matter can be easily resolved in terms of H_z , the vertical magnetic field. Recall from equations (3.2) through (3.9) that H_z appears only in the equations for the TE mode. Thus, with the x'-y' axes aligned with the strike, as in section B of this chapter

$$E'_{y} = -Z_{TE}H'_{x}$$

and

$$H'_z = r'_{TE} H'_{x}$$

In the x-y coordinate system, at an angle θ from the x'-y' system

$$H_{z} = H'_{z} = r'_{TE} H'_{x} = r'_{TE} (H_{x} \cos \theta - H_{y} \sin \theta)$$

$$H_{z} = H_{x} r'_{TE} \cos \theta - H_{y} r'_{TE} \sin \theta \qquad (3.43)$$

Recall from equation. (3.21) that for the general three dimensional model

$$H'_z = r'_{zx}H'_x + r'_{zy}H'_y$$

so that

$$H_{z} = H'_{z} = r'_{zx} H'_{x} + r'_{zy} H'_{y}$$

$$= r'_{zx} (H_{x} \cos \theta - H_{y} \sin \theta) + r'_{zy} (H_{x} \sin \theta + H_{y} \cos \theta)$$

$$= H_{x} (r'_{zx} \cos \theta + r'_{zy} \sin \theta) + H_{y} (r'_{zy} \cos \theta - r'_{zx} \sin \theta)$$

Thus

$$r_{zx} = r'_{zx} \cos \theta + r'_{zy} \sin \theta \qquad (3.44)$$

and

$$r_{zy} = r'_{zy} \cos \theta - r'_{zx} \sin \theta \qquad (3.45)$$

Comparison of equations (3.44) and (3.45) with equation (3.36) indicates that r_{zx} and r_{zy} like $Z_{o}(\theta)$ trace ellipses in the complex plane as θ varies. However, the important difference is that the magnitudes of r_{zx} and r_{zy} have only one peak every 180° instead of every 90° like $Z_{o}(\theta)$. Furthermore, one observes from equation (3.43) that in the two dimensional limit, the angle θ that maximizes r_{zy} is the strike direction.

Thus, when measured data is approximately two dimensional, the angle that maximizes $|r_{zx}|$ should correspond to one of the principal axes of

the Z matrix, and so it is possible to estimate the approximate strike direction and the corresponding $\mathbf{Z}_{\mbox{TE}}$ and $\mathbf{Z}_{\mbox{TM}}$.

IV. METHODS FOR ESTIMATING THE Z MATRIX FROM MEASURED DATA

Now that a considerable amount of attention has been given to the forms of the Z matrix for various classes of models and to possible interpretations of Z, it is time to consider some methods for estimating Z from measured E and H field data.

A. The General Problem

Consider the equation

$$E_x = Z_{xx}H_x + Z_{xy}H_y$$

where E_x , H_x , and H_y may be considered to be Fourier transforms of measured electric and magnetic field data. If one has two independent measurements of E_x , H_x , and H_y at a given frequency, denoted by E_{xl} , H_{xl} , H_{yl} , E_{x2} , H_{x2} and H_{y2} respectively, then

$$Z_{xx} = \frac{\begin{vmatrix} E_{xl} & H_{yl} \\ E_{x2} & H_{y2} \end{vmatrix}}{\begin{vmatrix} H_{xl} & H_{yl} \\ H_{x2} & H_{y2} \end{vmatrix}}$$

and

$$z_{xy} = \frac{\begin{vmatrix} H_{x1} & E_{x1} \\ H_{x2} & E_{x2} \end{vmatrix}}{\begin{vmatrix} H_{x1} & H_{y1} \\ H_{x2} & H_{y2} \end{vmatrix}}$$

provided

$$H_{xl}H_{y2} - H_{x2}H_{yl} \neq 0$$
 (4.1)

Equation (4.1) simply states the fact that the two field measurements must have different source polarizations. If the two have the same polarization, they are not independent.

Since any physical measurement of E or H will include some noise, it is usually desirable to make more than two independent measurements, and then to use some type of averaging that will reduce the effects of the noise. Suppose one has n measurements of E_x , H_x , and H_y at a given frequency. One can then estimate Z_{xx} and Z_{xy} in the mean square sense. That is, define

where E_{xi}^* is the complex conjugate of E_{xi} , etc., and then find the values of Z_{xx} and Z_{xy} that minimize † . Setting the derivatives of † with respect to the real and imaginary parts of Z_{xx} to zero yields

$$\sum_{i=1}^{n} E_{xi} H_{xi}^{*} = Z_{xx} \sum_{i=1}^{n} H_{xi} H_{xi}^{*} + Z_{xy} \sum_{i=1}^{n} H_{yi} H_{xi}^{*}$$
(4.2)

Similarly, setting the derivatives of $^{\sharp}$ with respect to the real and imaginary parts of $Z_{_{\mbox{XV}}}$ to zero yields

$$\frac{n}{2} E_{xi} H_{yi}^{*} = Z_{xx} \frac{n}{2} H_{xi} H_{yi}^{*} + Z_{xy} \frac{n}{2} H_{yi} H_{yi}^{*}$$
(4.3)

Notice that the summations represent auto and cross power density spectra. Equations (4.2) and (4.3) may then be solved s. multaneously for Z_{xx} and Z_{xy} . This solution will minimize the error caused by noise on E_x . It is possible to define other mean square estimates that minimize other types of noise. For example, if one takes

$$\Psi = \sum_{i=1}^{n} \left(\frac{E_{xi}}{Z_{xx}} - H_{xi} - \frac{Z_{xy}}{Z_{xx}} H_{yi} \right) \left(\frac{E_{xi}^{*}}{Z_{xx}^{*}} - H_{xi}^{*} - \frac{Z_{xy}^{*}}{Z_{xx}^{*}} H_{yi}^{*} \right)$$

the resulting solution will minimize the error introduced by noise on $\mathbf{H}_{\mathbf{v}}$.

There are four distinct equations that arise from the various mean square estimates. In terms of the auto and cross power density spectra, they are

$$\overline{E_{\mathbf{x}}}^{\mathbf{E}^{\star}} = Z_{\mathbf{x}\mathbf{x}} \overline{H_{\mathbf{x}}}^{\mathbf{E}^{\star}} + Z_{\mathbf{x}\mathbf{v}} \overline{H_{\mathbf{y}}}^{\mathbf{E}^{\star}}$$

$$(4.4)$$

$$\overline{E} \, \overline{E}^* = Z \, \overline{H} \, \overline{E}^* + Z \, \overline{H} \, \overline{E}^*$$

$$\times \, \overline{Y} \, \overline{$$

$$\overline{E_{X}} = \overline{Z_{X}} + \overline{H_{X}} + \overline{Z_{X}} + \overline{H_{X}}$$

$$(4.6)$$

and

$$\overline{E_{X}} = Z_{XX} + Z_{Y} + Z_{XY} + Z_{Y} + Z_{Y}$$

$$(4.7)$$

Strictly speaking, equations (4.4) through (4.7) are valid only if $\overline{E_X}_X^{E_X}$, $\overline{E_X}_X^{E_X}$, etc. represent the power density spectra at a discrete frequency w. In practice however, Z_{ij} are slowly varying functions of frequency, and as such, $\overline{E_X}_X^{E_X}$, etc. may be taken as averages over some finite bandwidth. This is fortunate since it facilitates the estimation of the power density spectra.

B. Estimation of Power Density Spectra

There are a variety of standard techniques available for estimating $E_{X,X}$, $E_{X,Y}$, etc., the auto and cross power density spectra, several of which will be considered here. In all the cases, it will be assumed that the field components are given as sampled time sequences.

- 1. One method that was frequently used in the past was that of using the auto and cross correlation functions of the field components. This method makes use of the fact that the Fourier transform of the auto correlation function of a given signal is equal to the power density spectrum of that signal. Also the Fourier transform of the cross correlation function between two signals is equal to the cross power density spectrum of the two signals. Blackman and Tukey (1958) have considered in detail the various aspects of estimating correlation functions and the corresponding power density spectra for sampled time sequences. They have given careful attention to the spectral windows that result from truncating the time sequences and the correlation functions. Hopkins (1966) and others have used this method for obtaining estimates of $\overline{E_x}$ $\overline{E_x}$, $\overline{E_x}$, etc. in magnetotelluric work. This method, when compared with the ones that will be considered next, has several disadvantages. First it is more time consuming on the computer when many cross spectra are needed. Second, it gives statistically correct results only when the signals are stationary. Finally, it is more susceptible to error from the side lobes of the spectral window when the spectra are not reasonably flat. Blackman and Tukey suggest that this third disadvantage can be circumvented to some extent by digitally prewhitening the time sequences prior to computing the correlation functions.
- 2. Another method for estimating the power density spectra of the field components begins by subdividing each of the time sequences into several blocks. For each data block one computes the Fourier transformation to obtain estimates of $E_x(\omega)$, $E_y(\omega)$, etc. Then one forms the products $E_xE_x^*$, $E_xE_y^*$, etc. Finally, for each frequency, one averages the products over the several time blocks, thus obtaining time averaged estimates of $E_xE_x^*$, $E_xE_y^*$, $E_xE_y^*$, etc. This method is particularly well suited to small digital computers since only one time block of data needs to be stored in memory at any given time, and the blocks may be quite small compared to the

total time sequences. Also this method is especially useful for situations where the signals contain noise bursts that are isolated in time. Such noise bursts may arise from tape drop-out, system saturation caused by large amplitude signals, or many other sources. Such noise bursts are often readily detectable so that data blocks containing them may simply be omitted from the time average.

- 3. Another method for estimating the power spectra that is very similar to the previous one consists of feeding the original time sequences into a bank of narrow band digital recursive filters spanning the desired frequency range. The outputs of these filters are then treated the same as the outputs of the block Fourier transforms of the previous method. This recursive filter method has essentially the same advantages as the previous method together with the additional advantage that it lends itself quite readily to obtaining spectral estimates equally spaced on a log frequency scale. This is because the recursive filters may be designed such that they all have the same Q and have the appropriate spacing on the frequency scale. Swift (1967) has used this technique.
- 4. For the final method to be considered here, one begins by Fourier transforming each of the entire time sequences. The products $E_{\mathbf{X}}E_{\mathbf{X}}^*$, $E_{\mathbf{X}}E_{\mathbf{Y}}^*$, etc. are then formed for each harmonic. Finally the products are averaged over several neighboring harmonics to obtain the desired bandwidth. As far as computation time is concerned, this method is quite efficient if one uses the Cooley-Tukey algorithm for fast Fourier transforms. In fact, for a given number of multiplications, the spectral windows obtainable by this method are better than those obtainable by any of the other methods considered here. (A detailed discussion of spectral windows is included in Chapter V.) This method, like the last one, lends itself readily to constant Q estimates of the spectral density since the number of harmonics averaged in each band may be made approximately proportional to the center

frequency of the band. The primary disadvantage of this method is that, compared to the two previous methods, it requires a fairly large number of storage locations; in general it requires a large computer. Actually, in a modified form which is not quite as efficient computationally, the Cooley-Tukey algorithm is applicable to small computers. For a detailed consideration of this algorithm, see Cooley (1965).

If then, by one means or another, estimates of the auto and cross power density spectra are obtained, one can proceed to estimate the elements of the Z matrix.

C. Estimation of Z from Auto and Cross Power Density Spectra Consider equations (4.4) through (4.7). Under certain conditions, these equations are independent so that any two of them may be solved simultaneously for Z_{xx} and Z_{xy} . Since there are six possible distinct pairs of equations, there are six ways to estimate Z_{xx} and Z_{xy} . For example, the six estimates for Z_{xy} are

$$\overline{Z}_{xy} = \frac{(\overline{H_x E_x^*})(\overline{E_x E_x^*}) - (\overline{H_x E_y^*})(\overline{E_x E_x^*})}{(\overline{H_x E_x^*})(\overline{H_y E_y^*}) - (\overline{H_x E_y^*})(\overline{H_y E_x^*})}$$
(4.8)

$$\overline{Z}_{xy} = \frac{(\overline{H_x E_x^*})(\overline{E_x H_x^*}) - (\overline{H_x H_x^*})(\overline{E_x E_x^*})}{(\overline{H_x E_x^*})(\overline{H_y H_x^*}) - (\overline{H_x H_x^*})(\overline{H_y E_x^*})}$$
(4.9)

$$\overline{Z}_{xy} = \frac{(\overline{H_x E_x^*})(\overline{E_x H_y^*}) - (\overline{H_x H_y^*})(\overline{E_x E_x^*})}{(\overline{H_x E_x^*})(\overline{H_y H_y^*}) - (\overline{H_x H_y^*})(\overline{H_y E_x^*})}$$
(4.10)

$$\overline{Z}_{xy} = \frac{(\overline{H}_{x} \overline{E}_{y}^{*}) (\overline{E}_{x} \overline{H}_{x}^{*}) - (\overline{H}_{x} \overline{H}_{x}^{*}) (\overline{E}_{x} \overline{E}_{y}^{*})}{(\overline{H}_{x} \overline{E}_{y}^{*}) (\overline{H}_{y} \overline{H}_{x}^{*}) - (\overline{H}_{x} \overline{H}_{x}^{*}) (\overline{H}_{y} \overline{E}_{y}^{*})}$$
(4.11)

$$\overline{Z}_{xy} = \frac{\overline{(H_x E_y^*)} \overline{(E_x H_y^*)} - \overline{(H_x H_y^*)} \overline{(E_x E_y^*)}}{\overline{(H_x E_y^*)} \overline{(H_y H_y^*)} - \overline{(H_x H_y^*)} \overline{(H_y E_y^*)}}$$
(4.12)

and

$$\overline{Z}_{xy} = \frac{\overline{(H_x H_x^{\star})} \overline{(E_x H_y^{\star})} - \overline{(H_x H_x^{\star})} \overline{(E_x H_x^{\star})}}{\overline{(H_x H_x^{\star})} \overline{(H_y H_y^{\star})} - \overline{(H_x H_y^{\star})} \overline{(H_y H_x^{\star})}}$$
(4.13)

where \overline{Z}_{xy} denotes a measured estimate of Z_{xy} .

It turns out that two of these expressions tend to be relatively unstable for the one dimensional case, particularly when the incident fields are unpolarized. For this case $E_x E_y^*$, $E_x H_x^*$, $E_y H_y^*$, and $H_x H_y^*$ tend toward zero, so that equations (4.10) and (4.11) become indeterminant. The other four expressions are quite stable and correctly predict $E_x = E_x H_y$ for the one dimensional case, provided the incident fields are not highly polarized.

This same thing is true of the other three impedance elements Z_{xx} , Z_{yx} , and Z_{yy} . In each case there are six ways to estimate Z_{ij} , two of which are unstable for one dimensional models with unpolarized incident fields. Also in each case the other four estimates are quite stable for any reasonable earth model provided the incident fields are not highly polarized.

As was mentioned earlier, any physical measurement of E or H will necessarily contain some noise. It is desirable now to consider how such noise will affect the Z estimates defined above. Suppose that

$$E_{x} = E_{xs} + E_{xn} \tag{4.14}$$

$$E_{y} = E_{ys} + E_{yn} \tag{4.15}$$

$$H_{x} = H_{xs} + H_{xn} \tag{4.16}$$

$$H_{y} = H_{ys} + H_{yn} \tag{4.17}$$

where

$$\begin{bmatrix} E_{xs} \\ E_{ys} \end{bmatrix} = \begin{bmatrix} Z_{xx} & Z_{xy} \\ Z_{yx} & Z_{yy} \end{bmatrix} \begin{bmatrix} H_{xs} \\ H_{ys} \end{bmatrix}$$

and E_{xn} , E_{yn} , H_{xn} and H_{yn} are noise terms. If the noise terms are all zero, then the four stable estimates of each of the elements of Z are the same, and

$$\overline{Z}_{ij} = Z_{ij}$$

On the other hand, when the noise terms are nonzero, the four estimates are in general different.

Equation (4.13) for Z_{xy} corresponds to the one that Swift (1967) used. He showed that his estimates of Z_{ij} were biased down by random noise on the H signal, but were not affected by random noise on the E signal. Similar arguments for the four stable estimates defined above indicate that in each case, two of them are biased down by random noise on H and are not biased by random noise on E (for example, equations (4.12) and (4.13) for \overline{Z}_{xy}) while the other two are biased up by random noise on E and are not biased by random noise on H (for example, equations (4.8) and (4.9) for \overline{Z}_{xy}). The effects of the noise are most easily seen for the one dimensional model. For this model, if the incident fields are depolarized so that \overline{E}_{xy}^{E*} , \overline{E}_{xy}^{E*} , and \overline{E}_{yy}^{E*} , and \overline{E}_{yy}^{E*} , and \overline{E}_{yy}^{E*} , and \overline{E}_{yy}^{E*} , reduce to

$$\overline{Z}_{xy} = \overline{E_x E_x} / \overline{H_y E_x^*}$$
(4.18)

Equations (4.12) and (4.15) reduce to

$$\overline{Z}_{XV} = \overline{E_{X}} + \sqrt{H_{V}} + \sqrt{H_{V}}$$
(4.19)

If one assumes that E_x and H_y are given by equations (4.14) and (4.17) and the E_{yn} and H_{xn} are random and independent of the signals and of each other, then the expected values of the power density spectra are

$$\langle \overline{E_{x}E_{x}^{*}} \rangle = \langle \overline{E_{xs}E_{xs}^{*}} \rangle + \langle \overline{E_{xn}E_{xn}^{*}} \rangle$$

$$\langle \overline{H_{y}H_{y}^{*}} \rangle = \langle \overline{H_{ys}H_{ys}^{*}} \rangle + \langle \overline{H_{yn}H_{yn}^{*}} \rangle$$

$$\langle \overline{E_{x}H_{y}^{*}} \rangle = \langle \overline{H_{y}E_{x}^{*}} \rangle^{*} = \langle \overline{E_{xs}H_{ys}^{*}} \rangle$$

Thus, if the spectral estimates contain enough terms in the average so that the cross terms may be neglected (i.e. $E_{xs}E_{xn}^*$, etc. are negligible), then equation (4.18) gives

$$\overline{Z}_{xy} = \frac{\overline{E_{xs} + E_{xn}} + \overline{E_{xn}} + \overline{E_{xn}}}{\overline{H_{ys}} + \overline{E_{xs}}} = Z_{xy} \left(1 + \frac{E_{noise power}}{E_{signal power}}\right)$$
 (4.20)

and equation (4.19) gives

$$\overline{Z}_{xy} = \frac{\overline{E}_{xs} + \overline{Y}_{ys}}{\overline{H}_{ys} + \overline{H}_{yn} + \overline{H}_{yn}} = Z_{xy} / (1 + \frac{H \text{ noise power}}{H \text{ signal power}})$$
 (4.21)

Thus the estimate shown in equation (4.20) is biased to the high side by random noise on E while the one in equation (4.21) is biased to the low side by random noise on H. For similar percentages of random noise on E and H, an average of the various estimates hopefully will be better than any one estimate by itself. Also the scatter between the various estimates should be a good measure of the amount of random noise present.

In practice of course things are not quite this neat because the assumption that the cross terms in the average power estimates are negigible may not be valid. For example, terms of the form $E_{xn}H_{yn}^*$ will not be

negligible if the two noises are coherent. Such might be the case for certain types of instrumentation noise or local industrial noise or 60 cps power line noise. Also terms of the form $\overline{E_{xs}E_{xn}^*}$ will not be negligible if the noise is coherent with the signal source. Even if all of the noise terms are random and independent of the signals and of each other, the cross terms may not be negligible if the average power estimates do not have enough degrees of freedom.

V. NOISE PROBLEMS

As was mentioned in the previous chapter, any physical measurement of E or H will include some noise. This noise may be in the form of a constant bias caused by inaccurate calibration of the measuring system, or it may be a nonlinear effect such as would result from drift in the sensitivity of the measuring system. On the other hand many types of noise are independent of the signal. These include such things as amplifier noise, 60 cps power line noise, digitizer round off noise, and, if the signals are recorded in analog form, tape recorder noise. Also, there is always the possibility of having source generated noise. For example, if the incident fields include some plane waves with horizontal wavelengths short compared to a skin depth in the earth, the resulting surface fields may be represented as containing noise.

In any event one can always represent the measured field components as sums of signals and noises as indicated in equations (4.14) through (4.17). The degree to which the noise terms are independent of the signal terms depends entirely upon the source of the noise. In the cases where the noise terms are dependent upon each other or upon the signal terms, the effects of the noise upon the Z estimates vary according to which estimates are used, and according to which signal and noise terms are coherent. No attempt has been made to catalogue all of the various possib a combinations of signals and coherent noises.

For the situation where the noise terms are independent of each other and independent of the signals, some interesting results can be shown.

A. General Incoherent Noise

As was mentioned in the previous chapter, the various estimates of the elements of the Z matrix are biased either up by random noise on E or down by random noise on H. This is caused by the fact that the auto power

dentity spectra are in general biased up by random noise, while the cross power density spectra are not biased. For example, suppose that

$$E_{x} = E_{xs} + E_{xn} \tag{5.1}$$

and

$$H_{y} = H_{ys} + H_{yn}$$
 (5.2)

where

$$\langle E_{xs}E_{xn}^* \rangle = 0$$
 (5.3)

$$\langle H_{ys}H_{yn}^* \rangle = 0$$
 (5.4)

$$\langle E_{xn}H_{yn}^* \rangle = 0$$
 (5.5)

and where the brackets < > denote "expected value of." Clearly, for this situation

$$\langle E_{X}E_{X}^{*}\rangle = \langle E_{XS}E_{XS}^{*}\rangle + \langle E_{XR}E_{XR}^{*}\rangle$$
 (5.6)

$$= +$$
 (5.7)

and

$$\langle E_{x}H_{y}^{*}\rangle = \langle E_{xs}H_{ys}^{*}\rangle$$
 (5.8)

Equation (5.8) implies that the cross power can be estimated to any arbitrary degree of accuracy by measuring the fields for a long enough period of time. On the other hand, equations (5.6) and (5.7) imply that the estimates of the auto powers will be biased regardless of the length of time that the fields are measured.

These ideas lead one to consider an alternate approach to the problem. Suppose that one performs two simultaneous independent measurements of one of the field components, say $\rm E_{_{X}}$. If the results are

$$E_{xi} = E_{xs} + E_{xni} \tag{5.9}$$

and

$$E_{x2} = E_{xs} + E_{xn2} \tag{5.10}$$

where

$$\langle E_{xs}E_{xnl}^{*}\rangle = 0 \tag{5.11}$$

$$\langle E E_{xs} E_{xn2}^* \rangle = 0 \tag{5.12}$$

and

$$\langle E_{xn}|E_{xn2}^* \rangle = 0$$
 (5.13)

then

$$\langle E_{x1}E_{x2}^* \rangle = \langle E_{xs}E_{xs}^* \rangle$$
 (5.14)

Equation (5.14) implies that the $\mathbf{E}_{\mathbf{x}}$ auto power density spectrum can be estimated to any arbitrary degree of accuracy from two simultaneous noisy measurements of $\mathbf{E}_{\mathbf{x}}$ if the measurements are taken for a long enough period of time and if the noises on the two measurements are independent.

In general, if one has double measurements of either the two tangential components of E or the two tangential components of H, one can obtain estimates of the four elements of the Z matrix that are not biased by random noise.

B. Numerical Noise

At this time consideration will be given to several specific types of numerical noise. The term numerical noise as used here refers to any noise that is artificially injected into the signal when the latter is sampled for numerical processing.

1. Perhaps the most commonly recognized form of numerical noise is that which is usually referred to as aliasing. In accordance with the sampling theorem, if a continuous function which is sampled at a rate f_0 has any frequency components greater than the Nyquist or folding frequency (equal to $f_0/2$), these components will be lost from the sampled version of the function.

If any spectral analysis is performed on the sampled function, the lost frequency components will appear folded down into the desired spectrum, and will of course represent noise. Since aliasing is a well documented and well understood phenomenon, nothing more will be said about it here except to note that anyone who deals with magnetotelluric data or any other form of sampled data should be aware of it.

2. The next type of noise that will be considered here is round off error on the analog-to-digital converter. This type of noise arises from the fact that the A-D converter has only a finite number of discrete levels. Typically the signal passes through many levels between sample points. For this reason, the noise can be characterized quite well as a sequence of independent random variables with amplitudes ranging from $\varepsilon/2$ to $-\varepsilon/2$ with a flat distribution where ε is the distance between adjacent levels on the A-D converter. Thus the noise spectrum will be flat. The total noise power for 2m data points will be

Total Noise Power =
$$\frac{1}{\varepsilon} \int_{-\varepsilon/2}^{\varepsilon/2} x^2 dx = \varepsilon^2/12$$
 (5.15)

Since the spectrum is flat, the average noise power per harmonic would be $\varepsilon^2/12\,\mathrm{m}$ for m harmonics. If the signal spectrum were also flat, the average signal power associated with each harmonic would be about (Me) $^2/12\,\mathrm{m}$ where M is the number of digitizer levels that corresponds to the maximum peak to peak amplitude of the signal. Thus, the signal to noise ratio would be on the order of M^2 . In practice, it frequently happens that the signal spectrum is not flat. In this case the expected signal to noise level for a given harmonic is about

$$= M^{2} m \frac{Signal power in harmonic}{Total signal power}$$
 (5.16)

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if there is a total of m harmonics.

As an experimental check of the digitizer noise, the following was done. A typical set of actual magnetic field data was selected. It was Fourier transformed, and each harmonic was multiplied by a theoretical Z computed from a typical layered model.. The resulting theoretical E was Fourier transformed back to the time domain and digitized; that is, rounded off to a given number of significant bits. The resulting E together with the original H were used to compute an apparent resistivity versus frequency curve. Figure 7 shows the individual harmonics of the true E power density spectrum along with the expected digitizer noise levels for eight and twelve bit digitizing. Figures 8 and 9 show apparent resistivity versus frequency for the individual harmonics for eight and twelve bit digitizing together with the true ρ_a computed from the assumed model. Figures 10 through 12 give the corresponding results when the power density spectra are first averaged in bands of constant Q. From these figures, it is seen that, as expected, the apparent resistivities computed from the individual harmonics have random scatter when the signal power is not sufficiently large compared to the noise. Also as expected, the apparent resistivities computed from the averaged power estimates are biased to the high side by random digitizer noise on E. These experimental results are consistent with the theoretical discussion of digitizer noise.

3. The next type of numerical noise that will be considered is that which results from truncating the time series to a finite length T. Suppose that one of the field components has an amplitude that is described by f(t) foall time. The Fourier transform $F(\omega)$ is then given by

$$F(\omega) = \int_{-\infty}^{\infty} f(t) e^{-j\omega t} dt \qquad (5.17)$$

It is then desired to approximate F(w) by \overline{F} (nw $_{O}$), a Fourier series representation

of f(t) over some time interval T. Thus

$$\overline{F}(n\omega_0) = \int_{-T/2}^{T/2} f(t) e^{-jn\omega_0 t} dt; n = 0 - 1, -2, ...$$
 (5.18)

where

$$\omega_{\rm O} = 2\pi/T$$
.

Notice that

$$\overline{F}(\omega) = \int_{-\infty}^{\infty} f(t) d(t) e^{-j\omega t} dt$$
 (5.19)

where d(t) = 1 for |t| < T/2 and d(t) = 0 for |t| > T/2. Thus, from the convolution theorem

$$\overline{F}(n\omega_{o}) = \int_{-\infty}^{\infty} F(\omega) D(n\omega_{o} - \omega) d\omega$$
 (5.20)

where

$$D(\omega) = \int_{-\infty}^{\infty} d(t) e^{-j\omega t} dt$$

$$= \int_{-\infty}^{T/2} e^{-j\omega t} dt$$

$$= T/2$$

$$= \frac{2\pi}{\omega} \frac{\sin(\pi\omega/\omega)}{(\pi\omega/\omega)}$$
(5.21)

 $D(\omega)$ is usually called the spectral window since the observed spectrum $F(\omega)$ is equal to the true spectrum $F(\omega)$ convolved with $D(\omega)$.

The spectral window defined by equation (5.21) is actually not very desirable since the side lobes go off only as $1/\omega$. A better window, usually known as the Hanning window is obtained by letting

$$d(t) = \begin{cases} .5 + .5 \cos \omega_{O} t & ; |t| < T/2 \\ 0 & ; |t| > T/2 \end{cases}$$
 (5.22)

Then

$$D(\omega) = \int_{-T/2}^{T/2} (.5 + .5 \cos \omega_{O} t) e^{-j\omega t} dt$$

$$-T/2$$

$$= \frac{\omega_{O}^{2} \sin (\pi \omega/\omega_{O})}{\omega (\omega_{O}^{2} - \omega^{2})}$$
(5.23)

The main lobe of this spectral window is twice as wide as the main lobe of the previous one; however, the side lobes go off as $1/\omega^3$. The two windows are compared in figure 13.

One could define windows that have even smaller side lobes; however, they would necessarily have wider main lobes, and as will be seen later, this is not desirable. The Hanning window seems to be an adequate compromise between main lobe width and side lobe height.

One is then faced with the fact that any physical estimate of the power density at a particular frequency w is necessarily a weighted average of the true power density over a band of frequencies, the weighting function being the spectral window D(w). If the impedance function that one is attempting to estimate does not change significantly over the bandwidth defined by D(w), then the estimate will not be corrupted by the truncation effects. In practice, however, the impedance does change some so that there will be some truncation noise. The problem is particularly severe if the power density spectra have resonant peaks or other steep slopes. If one is attempting to estimate the power density near the bottom of a steep slope, the contributions from the side lobes of the spectral window may be significant compared to the contribution from the main lobe. This effectively broadens the bandwidth over which the impedance function must not change.

These considerations lead one to inquire into the spectral behavior of the E and H fields used in magnetotelluric surveying. One would hope that the general shape of the spectra of the incident E and H fields might be more

or less independent of time and space coordinates. If this were the case, then the measured total H field, which is close to twice the incident H field, would also be reasonably stationary with respect to time and space coordinates, and hence it could be prewhitened. On the other hand, the total E field is a strong function of the local conductivity structure and hence, although it would be stationary with respect to time, the shape of the spectrum would change from one location to the next as the conductivity structure changes. But still, the surface impedance Z is a well behaved function of frequency and as such one would expect that if the E signals were passed through the same filters as were designed to prewhiten the H signals, the resulting filtered E signals would have a reasonably well behaved spectrum. This, in general, turns out to be the case. Actually, as is indicated by equations (2.16) and (2.27), Z tends on the average to be proportional to the square root of frequency so that an optimum filter for E would differ from the H filter by a factor of $1/\sqrt{w}$.

With these ideas in mind, a study was made of the spectra of some actual H field data recorded in central Texas. Figures 14 and 15 give composite plots of H_x and H_y power density spectra obtained from 104 different data samples recorded at five different sites in central Texas. This data was recorded by D. R. Word, and a magnetotelluric interpretation of the data is given by him (Word, 1969). From these figures it is apparent that at least for the locations and times involved here, the general shape of the H power density spectra is fairly well defined. However, there are some definite resonant peaks (for example, around .07 cps and around 2.5 cps) that appear in some of the spectra but are absent from others. These results are consistent with those obtained by other investigators (Hopkins, 1966), (Bleil, 1964). It is believed that if the analog H signals are prewhitened according to the general trends shown in figures 14 and 15, the Hanning window can be used without encountering any side lobe difficulties except perhaps immediately adjacent to the observed resonances.

In order to get an estimate of the effects of truncation upon the individual harmonics of the Fourier spectra, consider the following problem. Assume a one dimensional case with

$$E(\omega) = Z(\omega) H(\omega)$$
.

Suppose that the H signal is prewhitened with a filter that has a response $F_H(\omega)$, and the He E signal is passed through a filter whose response is $F_E(\omega)$ which may or may not be the same as $F_H(\omega)$. Assume that the outputs of these filters are $H_O(\omega)$ and $E_O(\omega)$ respectively, so that

$$Z(\omega) = \frac{E(\omega)}{H(\omega)} = \frac{E_O(\omega)}{H_O(\omega)} \cdot \frac{F_H(\omega)}{F_E(\omega)}$$
 (5.24)

Then define

$$G(\omega) = \frac{E_O(\omega)}{H_O(\omega)} = \frac{Z(\omega) F_E(\omega)}{F_H(\omega)}$$
 (5.25)

Thus $G(\omega)$ is the ratio of the prewhitened electric and magnetic field signals and will be equal to $Z(\omega)$ if the two prewhitening filters are the same. If the prewhitened signals are then sampled and a Fourier series analysis is performed on each, the results will be

$$\overline{H} (nw_0) = \int_{-\infty}^{\infty} H_0(nw_0 - w) D(w) dw$$
 (5.26)

and

$$\overline{E} (nw_o) = \int_{-\infty}^{\infty} E_o(nw_o - w) D(w) dw$$

$$= \int_{-\infty}^{\infty} H_o(nw_o - w) G(nw_o - w) D(w) dw \qquad (5.27)$$

where D(w) is again the spectral window used. If G were constant over the

width of the window, then one would have

$$\overline{E}(n\omega_{o}) = G(n\omega_{o}) \int_{-\infty}^{\infty} H_{o}(n\omega_{o} - \omega) D(\omega) d\omega$$

$$= G(n\omega_{o}) \overline{H}(n\omega_{o}) \qquad (5.28)$$

the desired result. In practice however, G usually varies some. Suppose that in the neighborhood of nw_O , G can be represented by the first two terms of a Taylor series expansion. Thus

$$G(\lambda) = G(n\omega_0) + (\lambda - n\omega_0) G'(n\omega_0)$$
 (5.29)

where

$$G'(w) = \frac{dG(w)}{dw}$$
 (5.30)

If one lets $\lambda = nw_0 - w$, equation (5.29) gives

$$G(n\omega_{o} - \omega) = G(n\omega_{o}) - \omega G'(n\omega_{o})$$
 (5.31)

Putting this into equation (5.27) gives

$$\overline{E}(n\omega_{O}) = \int_{-\infty}^{\infty} H_{O}(n\omega_{O} - \omega) [G(n\omega_{O}) - \omega G'(n\omega_{O})] D(\omega) d\omega$$

$$= G(n\omega_{O}) \overline{H}(n\omega_{O}) - G'(n\omega_{O}) \int_{-\infty}^{\infty} H_{O}(n\omega_{O} - \omega) D(\omega) \omega d\omega \qquad (5.32)$$

If one then defines

$$\overline{G}(nw_0) = \overline{E}(nw_0) / \overline{H}(nw_0)$$
 (5.33)

and

error =
$$[\overline{G}(n\omega_0) - G(n\omega_0)]/G(n\omega_0)$$
 (5.34)

then from equation (5.32)

$$\frac{1}{G(n\omega)} = G(n\omega) - G'(n\omega) - \frac{1}{\omega} H_0(n\omega - \omega) D(\omega) \omega d\omega$$

$$\int_{-\infty}^{\infty} H_0(n\omega - \omega) D(\omega) d\omega$$
(5.35)

and

error =
$$-\frac{G'(nw_0)}{G(nw_0)} = -\frac{\int_{-\infty}^{\infty} H_0(nw_0 - w) D(w) wdw}{\int_{-\infty}^{\infty} H_0(nw_0 - w) D(w) dw}$$
(5.36)

Assume now that the integrals in equation (5.36) can be approximated by summations of the form

$$\frac{\overline{H(nw_0)}}{H(nw_0)} = \int_{-\infty}^{\infty} H_0(nw_0 - w) D(w) dw$$

$$= \sum_{i=0}^{m} H_{on,i} D_i \qquad (5.37)$$

where

$$H_{On,i} = H_{O}(n\omega_{O} - i\Delta\omega)$$
 (5.38)

and

$$\sum_{i=-m}^{m} D_i = 1 \tag{5.39}$$

Then

$$\overline{W}(n\omega_{o}) = \int_{-\infty}^{\infty} H_{o}(n\omega_{o} - \omega) D(\omega) \omega d\omega$$

$$= \sum_{i=-m}^{m} H_{on,i} D_{i} \frac{i\Omega}{m}$$
(5.40)

where Ω is the maximum value of w contributing to the integral. That is, $w = \Omega$ corresponds to i = m.

Assume that for any fixed n, $H_{\text{on,i}}$ are a sequence of 2m+1 independent complex random variables whose components have normal distributions and zero means. Also assume that the original H signal was prewhitened enough so that over any given band, the expected value of the power density is constant. That is,

$$\langle H_{\text{on,i}}^{\dagger} H_{\text{on,i}}^{\dagger} \rangle = \sigma_{\text{n}}^{2}; i = 0, \pm 1, \pm 2, \dots \pm m$$
 (5.41)

Since H_{on,i} are assumed to be independent and have zero means,

$$\langle H_{\text{on,i}} \rangle = 0 \tag{5.42}$$

and

$$\langle H_{\text{on,i}} H_{\text{on,j}}^{\dagger} \rangle = 0 ; i \# j$$
 (5.43)

Since $H_{\text{on,i}}$ are complex normal random variables, \overline{H} (nw_o) and \overline{W} (nw_o), which are linear combinations of $H_{\text{on,i}}$, must also be complex normal random variables. Consider the statistics of \overline{H} (nw_o) and \overline{W} (nw_o).

$$\langle \overline{H} (n w_{o}) \rangle = \langle \sum_{i=-m}^{m} H_{on,i} D_{i} \rangle$$

$$= \sum_{i=-m}^{m} \langle H_{on,i} \rangle D_{i}$$

$$= 0$$

$$\langle \overline{H} (n w_{o}) \overline{H}^{*} (n w_{o}) \rangle = \langle (\sum_{i=-m}^{m} H_{on,i} D_{i}) (\sum_{i=-m}^{m} H_{on,j}^{*} D_{j}) \rangle$$

$$\langle \overline{H} (n w_{o}) \overline{H}^{*} (n w_{o}) \rangle = \langle (\sum_{i=-m}^{m} H_{on,i} D_{i}) (\sum_{i=-m}^{m} H_{on,j}^{*} D_{j}) \rangle$$

(Eq. cont'd on next page)

$$= \sum_{i=-m}^{m} \sum_{j=-m}^{m} D_{i}D_{j} < H_{on,i}H_{on,j}^{*} >$$

$$= \sum_{i=-m}^{m} D_{i}^{2} < H_{on,i}H_{on,i}^{*} >$$

$$= \sigma_{n}^{2} \sum_{i=-m}^{m} D_{i}^{2}$$

$$= \sigma_{n}^{2} \sum_{i=-m}^{m} D_{i}^{2}$$

$$< \overline{W}(nw_{o}) > = < \sum_{i=-m}^{m} H_{on,i}D_{i}\frac{i\Omega}{m} >$$

$$= \frac{\Omega}{m} \sum_{i=-m}^{m} < H_{on,i} > D_{i} i$$

$$= 0 \qquad (5.46)$$

$$< \overline{W}(nw_{o}) \overline{W}^{*}(nw_{o}) > = < (\sum_{i=-m}^{m} H_{on,i}D_{i}\frac{i\Omega}{m})(\sum_{j=-m}^{m} H_{on,j}^{*}D_{j}\frac{i\Omega}{m}) >$$

$$= (\frac{\Omega}{m})^{2} \sum_{i=-m}^{m} \sum_{j=-m}^{m} D_{i}D_{j} ij < H_{on,i}H_{on,j}^{*} >$$

$$= (\frac{\Omega}{m})^{2} \sigma_{n}^{2} \sum_{i=-m}^{m} i^{2}D_{i}^{2} \qquad (5.47)$$

$$<\overline{H} (n\omega_{o}) \overline{W}^{*} (n\omega_{o})> = <\left(\sum_{i=-m}^{m} H_{on,i} D_{i}\right) \left(\sum_{j=-m}^{m} H_{on,j}^{*} D_{j} \frac{i\Omega}{m}\right)>$$
(Eq. cont'd.)

$$= \frac{\Omega}{m} \sum_{i=-m}^{m} \sum_{j=-m}^{m} D_{i}D_{j} < H_{on,i}H_{on,j}^{*} >$$

$$= \frac{\Omega}{m} \sigma_{n}^{2} \sum_{i=-m}^{m} i D_{i}^{2} \qquad (5.48)$$

If the spectral window $D(\omega)$ is an even function of ω , then $D_i^2 = D_{-i}^2$ and

$$\sum_{i=-m}^{m} i D_{i}^{2} = 0 {(5.49)}$$

so that

that if

$$\langle \overline{H} (n\omega_0) \overline{W}^*(n\omega_0) \rangle = 0$$
 (5.56)

Thus, \overline{H} (nw_o) and \overline{W} (nw_o) are independent complex normal random variables with zero means and with variances defined by equations (5.45) and (5.47).

A standard exercise in random variable theory indicates that if two random variables X and Y are normal and independent with zero means and equal variances, then the function

$$V = \sqrt{X^2 + Y^2}$$

has a Rayleigh distribution (see for example, Papoulis, 1965). Since $\overline{H}(n\omega_0)$ and $\overline{W}(n\omega_0)$ are complex normal random variables with zero means, their real and imaginary parts satisfy the conditions of the above exercise. Thus $|\overline{H}(n\omega_0)|$ and $|\overline{W}(n\omega_0)|$ must have Rayleigh distributions.

Another standard exercise in random variable theory indicates

$$V = X/Y$$

then the distribution of V is given by

$$F_{V}(v) = \int_{0}^{\infty} \int_{-\infty}^{yv} f_{XY}(x,y) dx dy + \int_{-\infty}^{0} \int_{yv}^{\infty} f_{XY}(x,y) dx dy$$
 (5.51)

where $f_{XY}(x,y)$ is the joint density of X and Y (see Papoulis, 1965). If X and Y are independent and have Rayleigh distributions then equation (5.51) becomes

$$F_{V}(v) = \int_{0}^{\infty} \int_{0}^{yv} f_{X}(x) f_{Y}(y) dx dy$$

$$= \int_{0}^{\infty} f_{Y}(y) F_{X}(yv) dy$$

$$= \int_{0}^{\infty} \frac{y}{\alpha_{y}^{2}} e^{-y^{2}/2\alpha_{y}^{2}} [1 - e^{-(yv)^{2}/2\alpha_{x}^{2}}] dy$$

$$= 1 - \frac{1}{1 + (\frac{y}{\alpha})^{2}}$$
 (5.52)

where $\alpha_x^2 = \langle x^2 \rangle$ and $\alpha_y^2 = \langle y^2 \rangle$.

Now recall that $|H(nw_0)|$ and $|W(nw_0)|$ have Rayleigh distributions. From equations (5.45) and (5.47)

$$<|\overline{H}(nw_0)|^2> = \sigma_n^2 \sum_{i=-m}^m D_i^2$$
 (5.53)

and

$$< |\overline{W}(n\omega_0)|^2 > = (\frac{\Omega}{m})^2 \sigma_n^2 \sum_{i=-m}^{m} i^2 D_i^2$$
 (5.54)

Also, from equations (5.36), (5.37), and (5.40),

$$|error| = \left| \frac{G(n\omega_o) \overline{W}(n\omega_o)}{G'(n\omega_o) \overline{H}(n\omega_o)} \right|$$
 (5.55)

Recall that $F_{V}(v)$ is by definition the probability that $V \leq v$. Thus, equations

(5.52) through (5.55) combine to give

$$P\{|error| \leq \epsilon\} = 1 - \frac{1}{1 + (\epsilon \left| \frac{G(nw_0)}{G'(nw_0)} \right| \kappa)^2}$$

$$(5.56)$$

where

$$\kappa^{2} = \frac{\sum_{i=-m}^{m} D_{i}^{2}}{(\frac{\Omega}{m})^{2} \sum_{i=-m}^{m} i^{2} D_{i}^{2}}$$
(5.57)

and where $P\{X\}$ denotes the probability, then X occurs. Recall from equations (5.37) through (5.40) that the summations arose as approximations to integrals. If one now lets $m \to \infty$ and passes back to the integral formulation, equation

(5.57) becomes

$$\kappa^2 = \frac{\int_0^2 D^2(\omega) d\omega}{\int_0^2 \omega^2 D^2(\omega) d\omega}$$
 (5.58)

Since $D(\omega)$ has been assumed to be an even function of ω , and since

$$P\{|error| > \epsilon\} = 1 - P\{|error| \le \epsilon\}$$

one has from equation (5.56)

$$P\{|error| > \epsilon\} = \frac{1}{1 + \epsilon^2 \left| \frac{G(nw_0)}{G'(nw_0)} \right|^2 \int_{\infty}^{\infty} D(\omega)^2 d\omega}$$

$$\int_{0}^{\infty} w^2 D(\omega)^2 d\omega$$
(5.59)

If D(w) is a block window of width BW, equation (5.59) becomes

$$P\{|error| > \epsilon\} = \frac{1}{1 + \frac{12\epsilon^2}{(BW)^2} \left| \frac{G(nw_o)}{G'(nw_o)} \right|^2}$$

or

$$P\{|error| > \epsilon\} = \frac{1}{1 + 12\epsilon^2 \left| \frac{G(nw_o)}{\Delta G(nw_o)} \right|^2}$$
 (5.60)

where $\Delta G(nw_0) = G'(nw_0) \cdot BW = change in G(w)$ over a band of width BW around nw_. Similarly, for the Hanning window with

$$D(\omega) = \sin \frac{\pi \omega}{\omega_0} \left(\frac{\omega_0^2}{\omega(\omega_0^2 - \omega^2)} \right)$$
 (5.61)

one obtains

$$P\{|error| > \epsilon\} = \frac{1}{1 + \frac{3\epsilon^2}{\omega^2} \left| \frac{G(n\omega_0)}{G'(n\omega_0)} \right|}$$

$$(5.62)$$

It has been observed that for one dimensional models

$$-\frac{1}{2} \le \frac{d \log \sigma_{a}(\omega)}{d \log \omega} \le \frac{1}{2}$$
 (5.63)

Now if one uses the same prewhitening filters on E and H

$$|G(\omega)| = |Z(\omega)| = \sqrt{\omega \mu / \sigma_{a}(\omega)}$$
 (5.64)

and it follows that

$$\frac{1}{4} \le \frac{d \log |G(w)|}{d \log w} \le \frac{3}{4} \tag{5.65}$$

or

$$\frac{d \log |G(w)|}{d \log w} = \frac{w}{|G(w)|} \frac{d |G(w)|}{dw} \le \frac{3}{4}$$
 (5.66)

or, for the worst case

$$\frac{|G(nw_0)|}{|G'(nw_0)|} = \frac{4nw_0}{3}$$
 (5.67)

Thus, for this case equation (5.62) becomes

$$P\{|error| > \epsilon\} = \frac{1}{1 + \frac{16}{3} n^2 \epsilon^2}$$
 (5.68)

Equation (5.68) indicates that, as expected, the probability of the error being greater than ε goes down as ε increases. Also, as expected, the probable error decreases as n, the harmonic number, increases. The latter result is expected since $|\Delta G(\omega)/G(\omega)|$ should be proportional to the percentage bandwidth of the window, which in turn is inversely proportional to the harmonic number. The results of equation (5.68) are summarized in figure 16.

It is doubtful that the results shown in figure 16 are useful quantitatively because of the assumptions made about the form of $H_O(\omega)$, the prewhitened magnetic field signal. In particular, it was assumed that $\sigma_{H_O}^2 = \langle H_O(\omega) | H_O(\omega)^* \rangle \text{ is independent of frequency. In practice this is not attainable since, as noted earlier, magnetotelluric signals are not really stationary.}$

In order to get some type of estimate of the effects of truncation upon realistic data, the following experiment was performed. A typical set of actual magnetic field data was selected. It was Fourier transformed using the Hanning window, and each harmonic was multiplied by a theoretical Z computed from a typical layered model. The resulting theoretical E was Fourier transformed back to the time domain. This E, together with the original H, were truncated to some fraction of the original length. The resulting truncated E and H signals were Fourier transformed, and apparent resistivities were computed from each harmonic. These apparent resistivities were then compared with the true apparent resistivities for the assumed model. This experiment

was repeated for several different models with several different original data lengths and several different truncated data lengths. The results showed a very definite trend. In each case, the apparent resistivities computed from the first eight to ten harmonics were significantly in error. The higher harmonics showed very little error. The amount of error on the first few harmonics depended significantly upon how white the spectra were; the whiter spectra had less error. Figures 17 and 18 show the results of a typical run. Figure 17 shows the individual harmonics of the spectrum of a truncated H signal. Figure 18 shows the corresponding apparent resistivities along with the true apparent resistivity curve for the assumed model.

These considerations lead one to believe that the first few harmonics of a Fourier spectrum of typical magnetotelluric data are likely to be corrupted considerably by truncation error.

VI. CONCLUSION

The methods of analysis discussed in the foregoing chapters have been implemented in a digital computer program constructed by the author for use on the CDC 6600 computer at The University of Texas Computation Center. This program estimates the power density spectra of sampled E and H signals by computing the Fourier transforms of the sampled data using the Cooley-Tukey algorithm, and averaging the resulting auto and cross powers in frequency bands of constant percentage bandwidth as discussed in Chapter IV, Section B.4. The Hanning window discussed in Chapter V, Section B.3 is used for the Fourier transforms. The elements of the Z matrix are then estimated from the power density spectra using the techniques described in Chapter IV, Section C. The principal axes are then determined in accordance with the discussion in Chapter III, Sections C and D. Also the approximate strike direction is determined from the vertical magnetic field as discussed in Chapter III, Section E. As diagnostics, the tensor coherency mentioned in Chapter IV, Section C, and the two-dimensionality parameters mentioned in Chapter III, Section D, are determined.

This program has been used extensively for analysis of magnetotelluric data recorded in central Texas by Darrell Word. Samples of the results are given by Word (1969). For most of the data analyzed using this program, the resulting surface impedance estimates have been consistent and repeatable. In areas where the geology is reasonably one dimensional, these surface impedances have been successfully interpreted in terms of horizontally layered models. The resulting resistivity profiles have agreed quite well with independent observations such as resistivity well logs in cases where the latter have been available.

In areas where the geology is more complex, particularly where it is highly three dimensional, interpretation has not been so successful. However, even here the surface impedance estimates have been fairly repeatable. Thus,

it is believed that now, perhaps for the first time, the surface impedances have been measured more accurately than they can at present be interpreted. For this reason, it is believed that future contributions to the science of magnetotellurics must come in the area of interpretation.

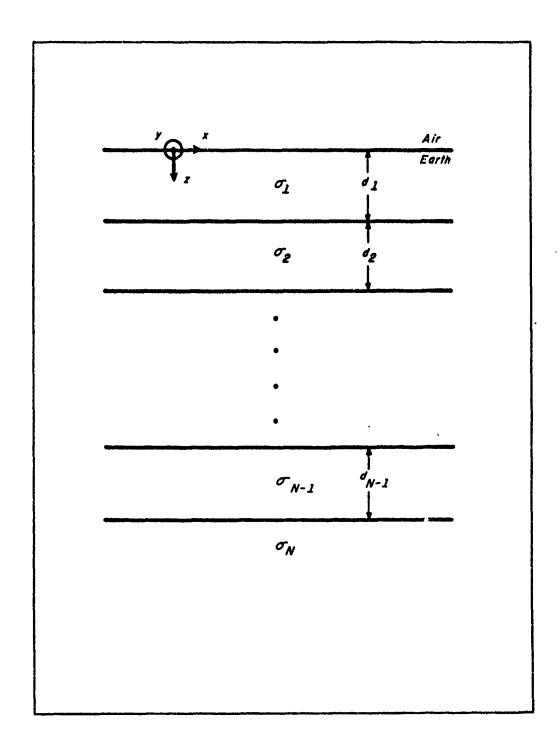


Fig. 1 Description of N Layer Model

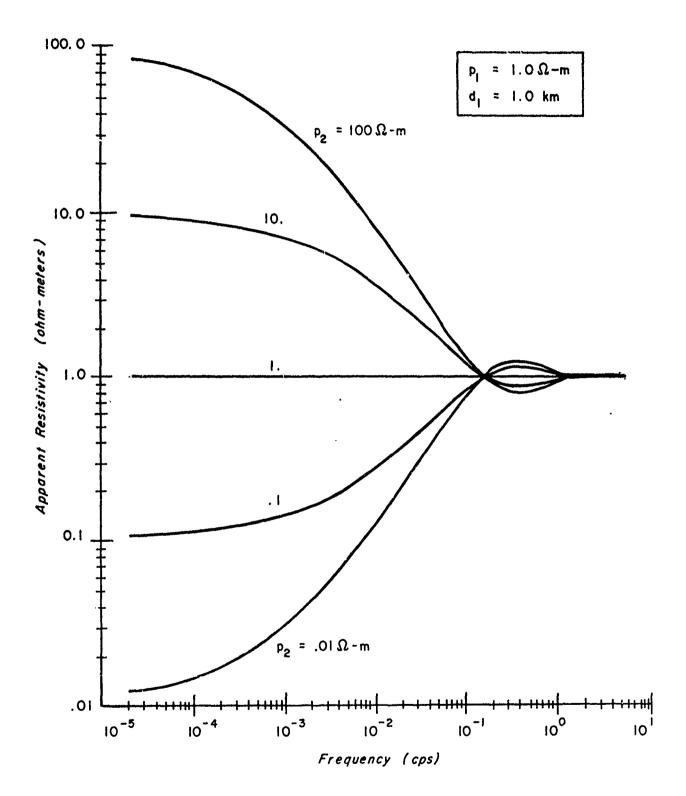


Fig. 2 Sample Two Layer Apparent Resistivity Curves

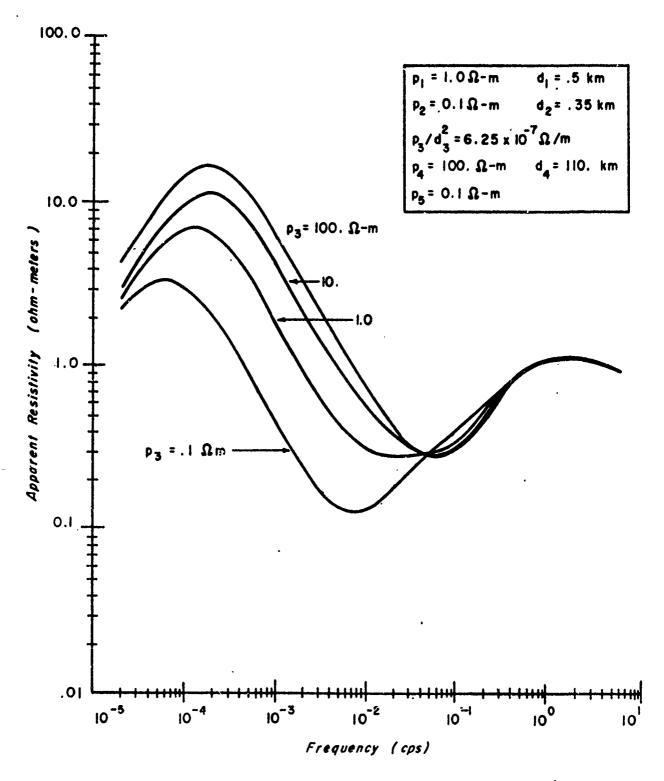


Fig. 3 Sample Five Layer Apparent Resistivity Curves

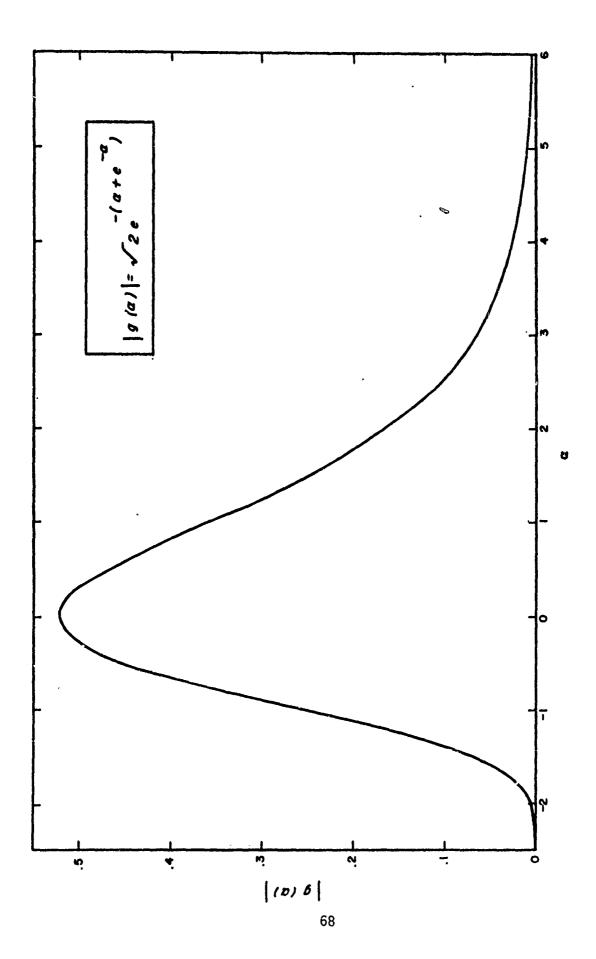


Fig. 4 Convolver for Linearized One Dimensional Problem

1

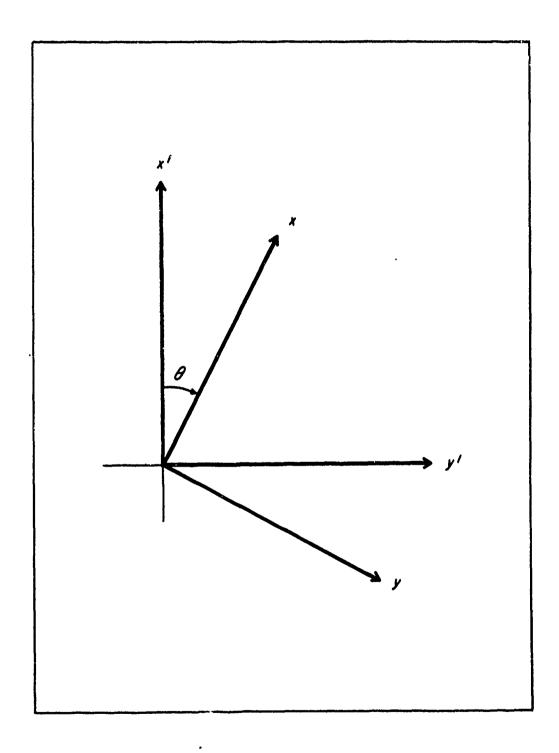


Fig. 5 Relative Orientation of x'-y' and x-y Coordinate Systems

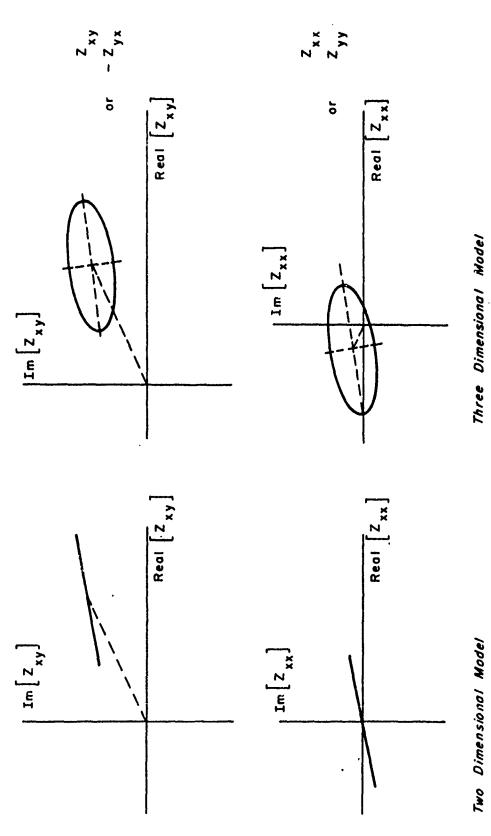


Fig. 6 Locii of Z; in the Complex Plane as the Measuring Axes are Rotated

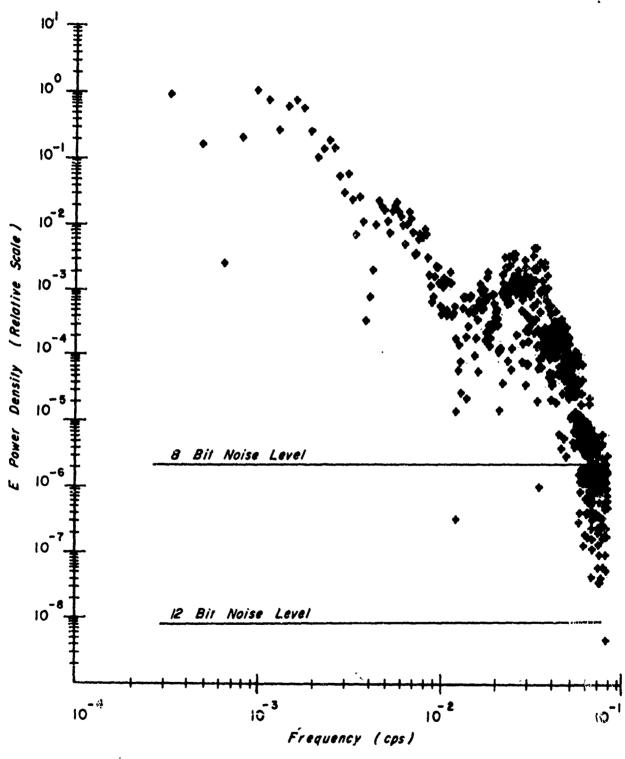


Fig. 7 Individual Harmonics of E Power Density Spectrum for Digitizer Noise Test with Expected Noise Levels for Eight and Twelve Bit Digitizing

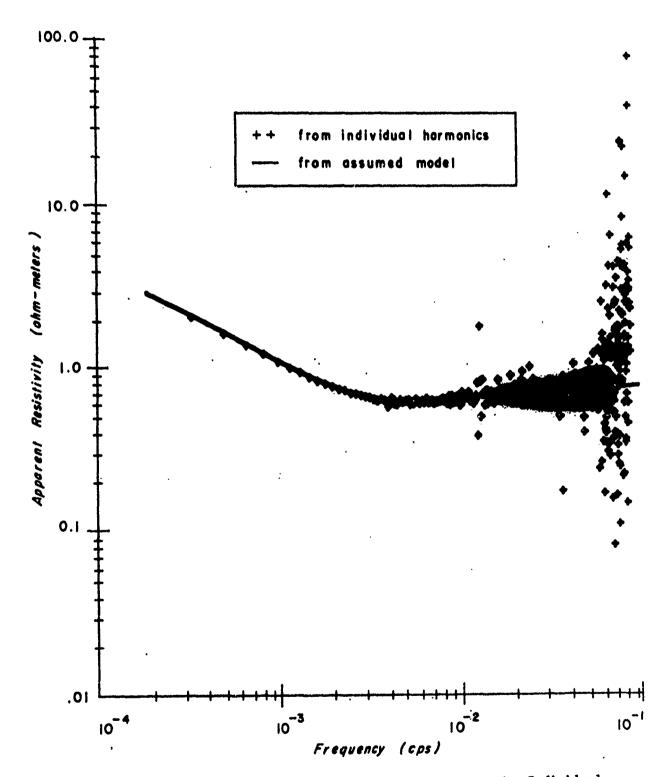


Fig. 8 Apparent Resistivity versus Frequency for Individual Harmonics for Eight Bit Digitizing

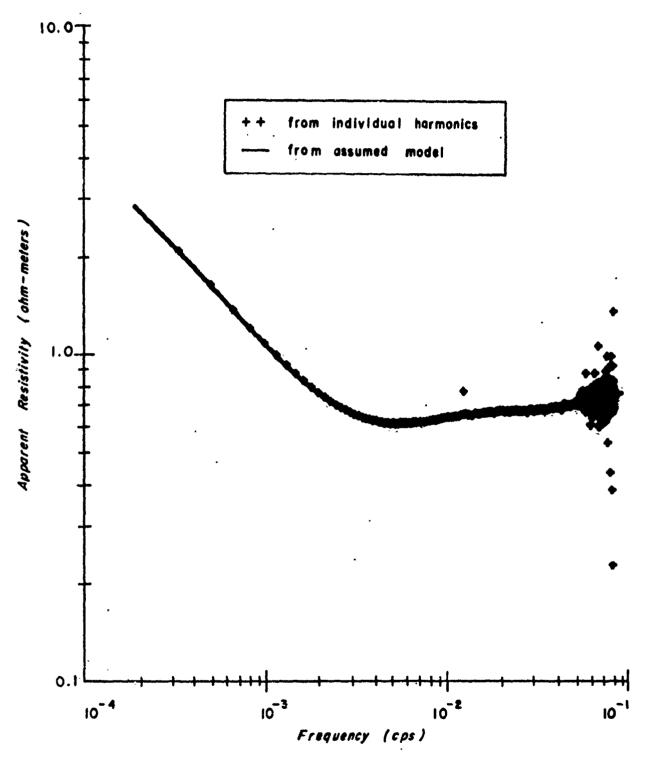


Fig. 9 Apparent Resistivity versus Frequency for Individual Harmonics for Twelve Bit Digitizing

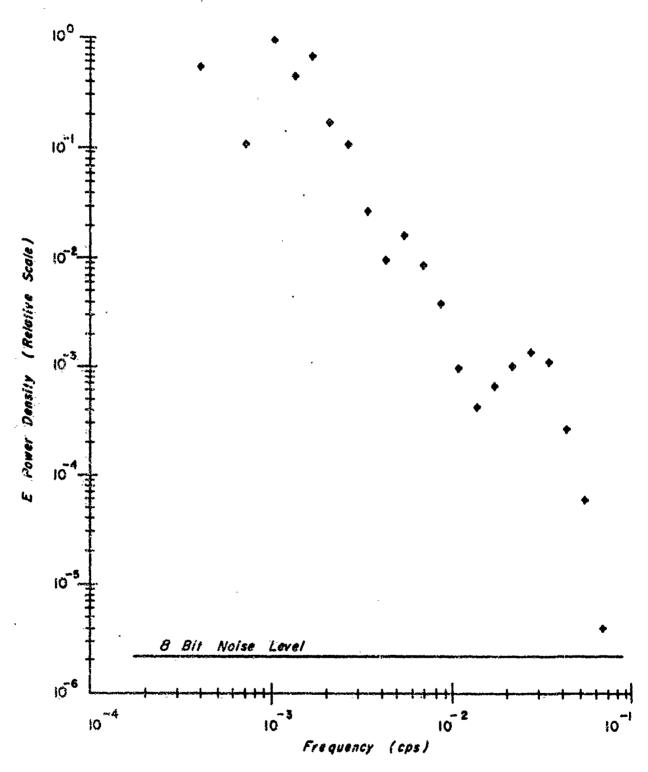


Fig. 10 Average E Power Density Spectrum for Digitizer Noise Test with Expected Noise Level for Eight Bit Digitizing

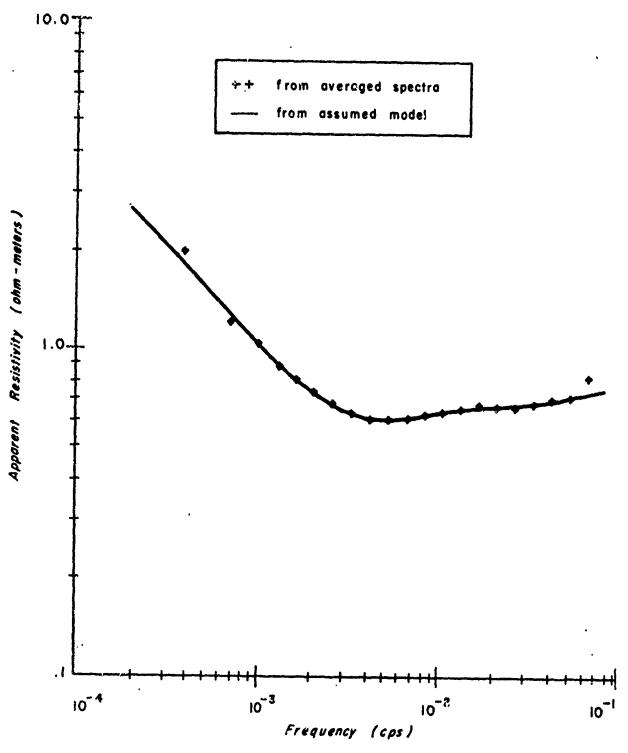


Fig. 11 Apparent Resistivity versus Frequency for Average Power Density Spectra with Eight Bit Digitizing

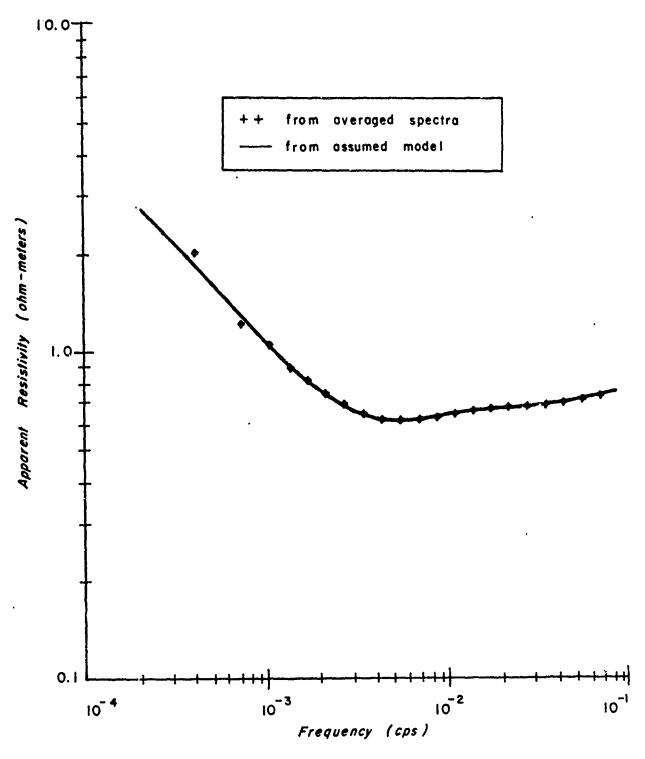


Fig. 12 Apparent Resistivity versus Frequency for Average Power Density Spectra with Twelve Bit Digitizing

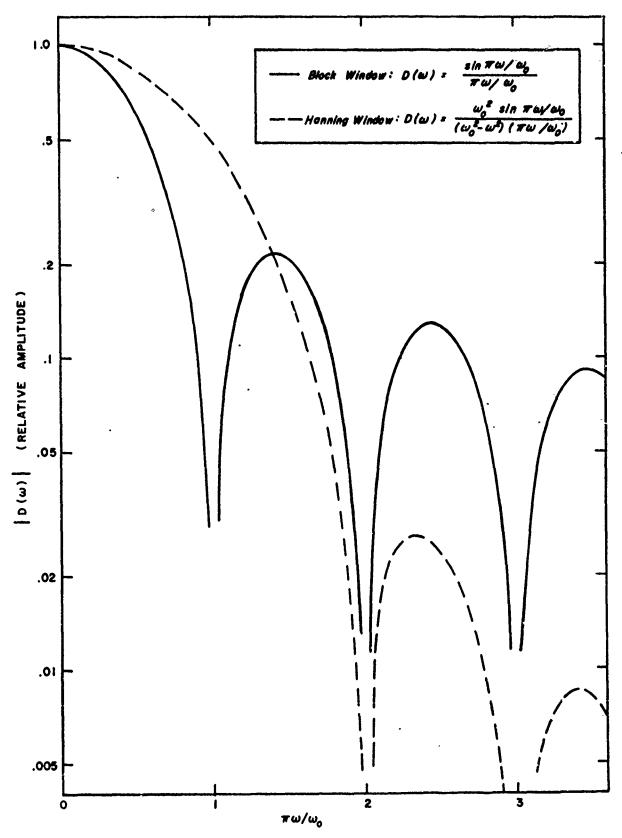


Fig. 13 Comparison of the Block and Hanning Spectral Windows

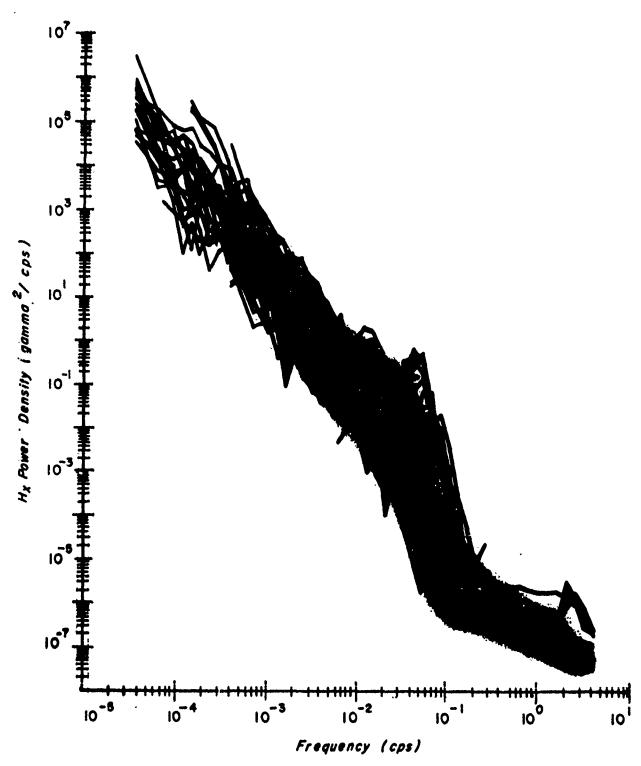


Fig. 14 H Power Density Spectra for 104 Different Data Samples Recorded in Central Texas

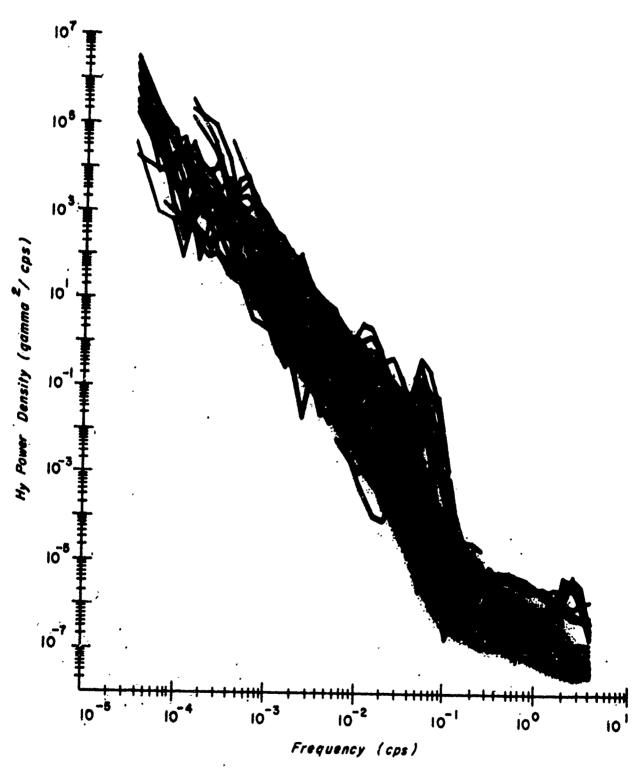


Fig. 15 H Power Density Spectra for 104 Different Data Samples Recorded in Central Texas

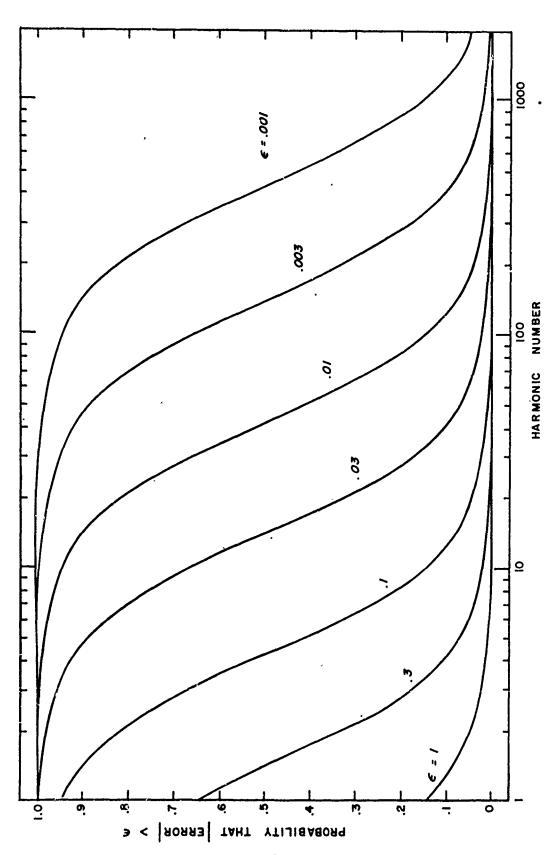


Fig. 16 Probability of Truncation Error on Impedance Estimates from Individual Harmonics

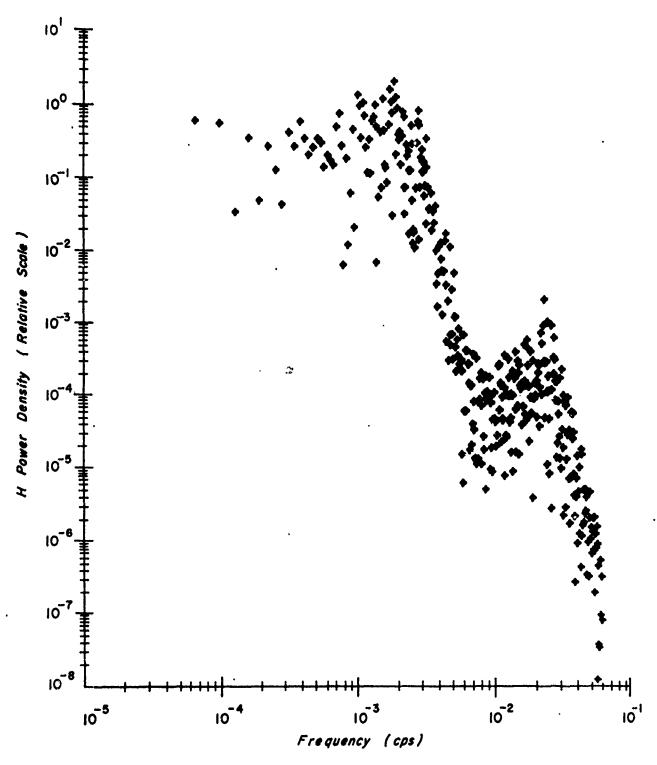


Fig. 17 Individual Harmonics of the Spectrum of a Truncated H Signal

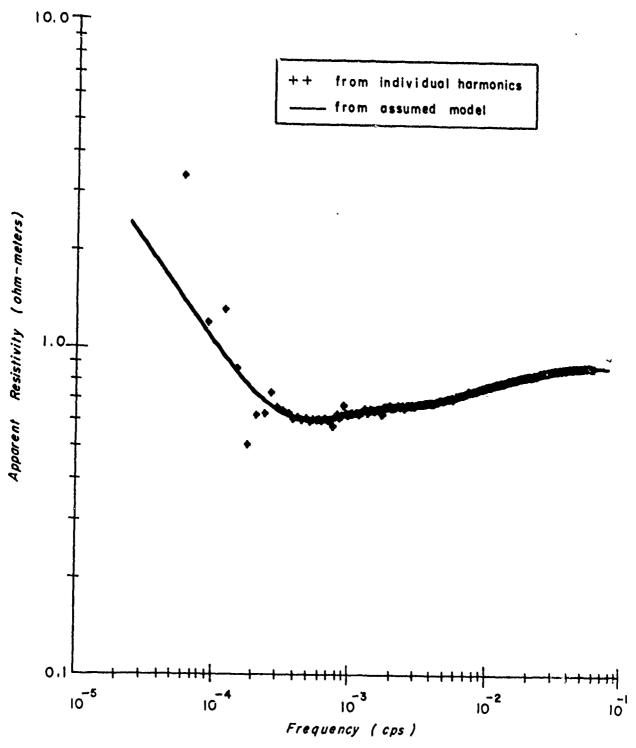


Fig. 18 Apparent Resistivity Estimates from Individual Harmonics of Truncated E and H Signals

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Magnetotelluric prospecting is a method of geophysical exploration that makes use of the fluctuations in the natural electric and magnetic fields that surround the earth. These fields can be measured at the surface of the earth and they are related to each other by a surface impedance that is a function of the conductivity structure of the earth's substrata.

This report describes some new methods for analyzing and interpreting magnetotelluric data. A discussion is given of the forms of the surface impedance for various classes of models, including one, two and three dimensional models. Here, an n dimensional model is one in which the parameters describing the model are functions of at most n space coordinates. Methods are discussed for estimating the strike direction for data that is at least approximately two dimensional. A new linearized approach to the one dimensional problem is discussed. Subject to the approximations of the linearization, it is shown that under appropriate transformations of the frequency and depth scales, the reciprocal of the surface impedance as a function of frequency is equal to the square root of the conductivity as a function of depth convolved with a linear response function that is somewhat like a low pass filter.

Included in this report is a comparison of several methods of estimating the auto and cross power density spectra of measured field data, and of several methods for estimating the surface impedance from these spectra. The effects of noise upon these estimates are considered in some detail. Special emphasis is given to several types of artificial noise including aliasing, round off or digitizer noise, and truncation effects. Truncation effects are of the most interest since they depend upon the particular window used in the spectral analysis.

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